## General Description

The MAX6870/MAX6871 EEPROM-configurable, multivoltage supply sequencers/supervisors monitor several voltage detector inputs, two auxiliary inputs, and four general-purpose logic inputs. The MAX6870/MAX6871 feature programmable outputs for highly configurable power-supply sequencing applications. The MAX6870 features six voltage detector inputs and eight programmable outputs, while the MAX6871 features four voltage detector inputs and five programmable outputs. Manual reset and margin disable inputs offer additional flexibility.
All voltage detectors offer two configurable thresholds for undervoltage/overvoltage or dual undervoltage detection. One high voltage input (IN1) provides detector threshold voltages from +2.5 V to +13.2 V in 50 mV increments, or from +1.25 V to +7.625 V in 25 mV increments. A bipolar input (IN2) provides detector threshold voltages from $\pm 2.5 \mathrm{~V}$ to $\pm 15.25 \mathrm{~V}$ in 50 mV increments, or from $\pm 1.25 \mathrm{~V}$ to $\pm 7.625 \mathrm{~V}$ in 25 mV increments. Positive inputs (IN3-IN6) provide detector threshold voltages from +1 V to +5.5 V in 20 mV increments, or from +0.5 V to +3.05 V in 10 mV increments.

Programmable output stages control power-supply sequencing or system resets/interrupts. Programmable output options include: active-high, active-low, opendrain, weak pullup, push-pull, and charge pump. Programmable timing delay blocks configure each output to wait between $25 \mu$ s and 1600 ms before deasserting. A fault register logs the condition that caused each output to assert (undervoltage, overvoltage, manual reset, etc.).
An internal 10-bit ADC monitors the voltage detector inputs, and two auxiliary inputs through a multiplexer that automatically sequences through all inputs every 200 ms . A SMBus ${ }^{\top \mathrm{M}}-/\left.\right|^{2} \mathrm{C}^{\top}$-compatible, serial data interface programs and communicates with the configuration EEPROM, the configuration registers, the internal 4kb user EEPROM, the ADC registers, and the fault registers of the MAX6870/MAX6871.
The MAX6870/MAX6871 are available in a $7 \mathrm{~mm} \times 7 \mathrm{~mm}$ $x 0.8 \mathrm{~mm} 32-$ pin thin QFN package and operate over the extended $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ temperature range.

## Applications

Telecommunications/Central Office Systems
Networking Systems
Servers/Workstations
Basestations
Storage Equipment
Multimicroprocessor/Voltage Systems
Pin Configurations, Typical Operating Circuit, and Selector Guide appear at end of data sheet.

- Six (MAX6870) or Four (MAX6871) Configurable Input Voltage Detectors

One High Voltage Input ( +1.25 V to +7.625 V or +2.5 V to +13.2 V Thresholds)
One Bipolar Voltage Input ( $\pm 1.25 \mathrm{~V}$ to $\pm 7.625 \mathrm{~V}$ or $\pm 2.5 \mathrm{~V}$ to $\pm 15.25 \mathrm{~V}$ Thresholds)
Four (MAX6870) or Two (MAX6871) Positive Voltage Inputs ( +0.5 V to +3.05 V or +1 V to +5.5 V Thresholds)

- Four General-Purpose Logic Inputs
- Two Configurable Watchdog Timers
- Eight (MAX6870) or Five (MAX6871)

Programmable Outputs
Active-High, Active-Low, Open-Drain, Weak Pullup, Push-Pull, Charge-Pump
Timing Delays from $25 \mu \mathrm{~s}$ to 1600 ms

- 10-Bit Internal ADC Monitors the Input Voltage Detectors and Two Auxiliary Inputs
- Margining Disable and Manual Reset Controls
- Internal 1.25V Reference or External Reference Input
- 4kb Internal User EEPROM Endurance: 100,000 Erase/Write Cycles Data Retention: 10 Years
- ${ }^{2} \mathrm{C} /$ SMBus-Compatible Serial Configuration/Communication Interface
- $\pm 1 \%$ Threshold Accuracy

Ordering Information

| PART | TEMP RANGE | PIN- <br> PACKAGE | PKG <br> CODE |
| :---: | :---: | :--- | :---: |
| MAX6870ETJ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 32 Thin QFN | T3277-2 |
| MAX6871ETJ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 32 Thin QFN | T3277-2 |

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# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

## ABSOLUTE MAXIMUM RATINGS



Continuous Power Dissipation ( $\mathrm{T}_{\mathrm{A}}=+70^{\circ} \mathrm{C}$ ) 32-Pin $7 \mathrm{~mm} \times 7 \mathrm{~mm}$ Thin QFN (derate $33.3 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $+70^{\circ} \mathrm{C}$ ). $\qquad$ 2667 mW Operating Temperature Range $\qquad$ $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ Maximum Junction Temperature ..................................... $+150^{\circ} \mathrm{C}$ Storage Temperature Range ... $\qquad$ $+150^{\circ} \mathrm{C}$ Lead Temperature (soldering, 10s) $\qquad$ $+300^{\circ} \mathrm{C}$

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ELECTRICAL CHARACTERISTICS

$\left(\mathrm{V}_{\mathrm{IN} 1}=+6.5 \mathrm{~V}\right.$ to $+13.2 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 2}=+10 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 3}$ to $\mathrm{V}_{\mathrm{IN} 6}=+2.7 \mathrm{~V}$ to $+5.5 \mathrm{~V}, \mathrm{AUXIN}_{-}=\mathrm{GPI}=\mathrm{GND}, \overline{\mathrm{MARGIN}}=\overline{\mathrm{MR}}=\mathrm{DBP}, \mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$, unless otherwise noted. Typical values are at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.) (Notes 1 and 2)

| PARAMETER | SYMBOL | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Operating Voltage Range (Note 3) | VIN1 | Voltage on IN1 to ensure the device is fully operational, IN3 to IN6 = GND |  | 4.0 |  | 13.2 | V |
|  | VIN3 to VIN6 | Voltage on any one of IN3 to IN6 to ensure the device is fully operational, IN1 = GND |  | 2.7 |  | 5.5 |  |
| IN1 Supply Voltage (Note 3) | VIN1P | Minimum voltage on IN1 to guarantee that the device is powered through IN1 |  |  |  | 6.5 | V |
| Undervoltage Lockout | VUVLO | Minimum voltage on one of IN3 to IN6 to guarantee the device is EEPROM configured. |  |  |  | 2.5 | V |
| Supply Current | Icc | $\mathrm{V}_{\text {IN } 1}=+13.2 \mathrm{~V}$, IN2 to IN6 = GND, no load |  |  | 1.2 | 1.5 | mA |
|  |  | Writing to configuration registers or EEPROM, no load |  |  | 1.3 | 2 |  |
| Threshold Range | $V_{\text {TH }}$ | VIN1 (50mV incremen |  | 2.5 |  | 13.2 | V |
|  |  | $\mathrm{V}_{\text {IN1 }}(25 \mathrm{mV}$ increments) |  | 1.250 |  | 7.625 |  |
|  |  | VIN2 ( 50 mV increments) |  | $\pm 2.50$ |  | $\pm 15.25$ |  |
|  |  | $\mathrm{V}_{\text {IN2 }}(25 \mathrm{mV}$ increments) |  | $\pm 1.250$ |  | $\pm 7.625$ |  |
|  |  | VIN3 to VIN6 (20mV increments) |  | 1.0 |  | 5.5 |  |
|  |  | VIN3 to VIN6 (10mV increments) |  | 0.50 |  | 3.05 |  |
| Threshold Accuracy |  | IN1 to IN6 positive, VIN_ falling | $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ | -1.0 |  | +1.0 | \% |
|  |  |  | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -1.5 |  | +1.5 |  |
|  |  | $-15.25 \mathrm{~V} \leq \mathrm{V}_{\mathrm{IN} 2} \leq-5 \mathrm{~V},$ <br> VIN2 falling | $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ | -1.5 |  | +1.5 |  |
|  |  |  | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -2 |  | +2 |  |
|  |  | $\begin{aligned} & -5 \mathrm{~V} \leq \mathrm{V}_{\text {IN2 }} \leq 0, \mathrm{~V}_{\text {IN } 2} \\ & \text { falling } \end{aligned}$ | $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ | -75 |  | +75 | mV |
|  |  |  | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -100 |  | +100 |  |
| Threshold Hysteresis | $\mathrm{V}_{\text {TH-HYST }}$ |  |  | 0.3 |  |  | \% $\mathrm{V}_{\text {TH }}$ |
| Reset Threshold Temperature Coefficient | $\Delta \mathrm{V}_{\mathrm{TH}} /{ }^{\circ} \mathrm{C}$ |  |  |  | 10 |  | $\begin{gathered} \mathrm{ppm} / \\ { }^{\circ} \mathrm{C} \end{gathered}$ |
| Threshold-Voltage Differential Nonlinearity | $V_{\text {TH }}$ DNL |  |  | -1 |  | +1 | LSB |

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

## ELECTRICAL CHARACTERISTICS (continued)

$\left(\mathrm{V}_{\mathrm{IN} 1}=+6.5 \mathrm{~V}\right.$ to $+13.2 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 2}=+10 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 3}$ to $\mathrm{V}_{\mathrm{IN}}=+2.7 \mathrm{~V}$ to $+5.5 \mathrm{~V}, \mathrm{AUXIN}=\mathrm{GPI}=\mathrm{GND}, \overline{\mathrm{MARGIN}}=\overline{\mathrm{MR}}=\mathrm{DBP}, \mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$, unless otherwise noted. Typical values are at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.) (Notes 1 and 2)


## EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC

## ELECTRICAL CHARACTERISTICS (continued)

$\left(\mathrm{V}_{\mathrm{IN} 1}=+6.5 \mathrm{~V}\right.$ to $+13.2 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 2}=+10 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 3}$ to $\mathrm{V}_{\mathbb{I N} 6}=+2.7 \mathrm{~V}$ to $+5.5 \mathrm{~V}, \mathrm{AUXIN}_{-}=\mathrm{GPI}=\mathrm{GND}, \overline{\mathrm{MARGIN}}=\overline{\mathrm{MR}}=\mathrm{DBP}, \mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$, unless otherwise noted. Typical values are at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.) (Notes 1 and 2)


## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC

## TIMING CHARACTERISTICS

$\left(\operatorname{IN} 1=G N D, \mathrm{~V}_{\mathrm{IN}}=+10 \mathrm{~V}, \mathrm{~V} \operatorname{IN} 3\right.$ to $\mathrm{V} \operatorname{IN} 6=+2.7 \mathrm{~V}$ to $+5.5 \mathrm{~V}, \mathrm{AUXIN}_{-}=\mathrm{GPI}=\mathrm{GND}, \overline{\mathrm{MARGIN}}=\overline{\mathrm{MR}}=\mathrm{DBP}, \mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$, unless otherwise noted. Typical values are at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.) (Notes 1 and 2)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TIMING CHARACTERISTICS (Figure 2) |  |  |  |  |  |  |
| Serial Clock Frequency | fsCL |  |  |  | 400 | kHz |
| Clock Low Period | tLow |  | 1.3 |  |  | $\mu \mathrm{s}$ |
| Clock High Period | thigh |  | 0.6 |  |  | $\mu \mathrm{s}$ |
| Bus-Free Time | tBUF |  | 1.3 |  |  | $\mu \mathrm{s}$ |
| START Setup Time | tSU:STA |  | 0.6 |  |  | $\mu \mathrm{s}$ |
| START Hold Time | thD:STA |  | 0.6 |  |  | $\mu \mathrm{s}$ |
| STOP Setup Time | tSu:STO |  | 0.6 |  |  | $\mu \mathrm{s}$ |
| Data-In Setup Time | tSU:DAT |  | 100 |  |  | ns |
| Data-In Hold Time | thD:DAT |  | 0 |  | 900 | ns |
| Receive SCL/SDA Minimum Rise Time | $t_{R}$ | (Note 8) |  | $\begin{aligned} & 20+ \\ & 0.1 \times \\ & \text { CBUS } \end{aligned}$ |  | ns |
| Receive SCL/SDA Maximum Rise Time | tR | (Note 8) |  | 300 |  | ns |
| Receive SCL/SDA Minimum Fall Time | $\mathrm{tF}_{\text {F }}$ | (Note 8) |  | $\begin{aligned} & 20+ \\ & 0.1 x \\ & \text { CBUS } \end{aligned}$ |  | ns |
| Receive SCL/SDA Maximum Fall Time | $\mathrm{t}_{\mathrm{F}}$ | (Note 8) |  | 300 |  | ns |
| Transmit SDA Fall Time | $\mathrm{tF}_{\text {F }}$ | CBus $=400 \mathrm{pF}$ | $\begin{aligned} & 20+ \\ & 0.1 \times \\ & \text { CBUS } \end{aligned}$ |  | 300 | ns |
| Pulse Width of Spike Suppressed | tsp | (Note 9) |  | 50 |  | ns |
| EEPROM Byte Write Cycle Time | twR | (Note 10) |  |  | 11 | ms |

Note 1: Specifications guaranteed for the stated global conditions. The device also meets the parameters specified when $0<V_{\text {IN1 }}$ $<+6.5 \mathrm{~V}$, and at least one of $\mathrm{V}_{\mathrm{IN} 3}$ through $\mathrm{V}_{\mathrm{IN}}$ is between +2.7 V and +5.5 V , while the remaining $\mathrm{V}_{\mathrm{IN}}$ through $\mathrm{V}_{\mathrm{IN6}}$ are between 0 and +5.5 V .
Note 2: Device may be supplied from any one of IN_, except IN2.
Note 3: The internal supply voltage, measured at ABP, equals the maximum of $\operatorname{IN} 3$ to $\operatorname{IN} 6$ if $\mathrm{V}_{\mathrm{IN} 1}=0$, or equals +5.4 V if $\mathrm{V}_{\mathrm{IN} 1}>$ +6.5 V . For $+4 \mathrm{~V}<\mathrm{V}_{\mathrm{IN} 1}<+6.5 \mathrm{~V}$ and $\mathrm{V} \operatorname{IN} 3$ through $\mathrm{V}_{\mathrm{IN}} 6>+2.7 \mathrm{~V}$, the input that powers the device cannot be determined.
Note 4: $100 \%$ production tested at $T_{A}=+25^{\circ} \mathrm{C}$ and $\mathrm{T}_{\mathrm{A}}=+125^{\circ} \mathrm{C}$. Specifications at $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ are guaranteed by design.
Note 5: VIN_> $0.3 \times$ ADC range.
Note 6: Does not include the inaccuracy of the external +1.25 V voltage reference.
Note 7: DNL implicitly guaranteed by design in a sigma-delta converter.
Note 8: $\quad$ Cbus $=$ total capacitance of one bus line in pF . Rise and fall times are measured between $0.1 \times V_{B U S}$ and $0.9 \times$ VBUS.
Note 9: Input filters on SDA, SCL, A0, and A1 suppress noise spikes < 50 ns.
Note 10: An additional cycle is required when writing to configuration memory for the first time.

## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC

Typical Operating Characteristics
$\left(\mathrm{V}_{\mathrm{IN} 1}=+6.5 \mathrm{~V}\right.$ to $+13.2 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 2}=+10 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 3-\mathrm{IN} 6}=+2.7 \mathrm{~V}$ to $+5.5 \mathrm{~V}, \mathrm{AUXIN},=\mathrm{GP} I_{-}=\mathrm{GND}, \overline{\mathrm{MARGIN}}=\overline{\mathrm{MR}}=\mathrm{DBP}, \mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, unless otherwise noted.)



## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC

## Typical Operating Characteristics (continued)

$\left(\mathrm{V}_{\mathrm{IN} 1}=+6.5 \mathrm{~V}\right.$ to $+13.2 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 2}=+10 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN} 3-\mathrm{IN} 6}=+2.7 \mathrm{~V}$ to $+5.5 \mathrm{~V}, \mathrm{AUXIN}_{-}=\mathrm{GPI}_{-}=\mathrm{GND}, \overline{\mathrm{MARGIN}}=\overline{\mathrm{MR}}=\mathrm{DBP}, \mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, unless otherwise noted.)


# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

| PIN |  | NAME | FUNCTION |
| :---: | :---: | :---: | :---: |
| MAX6870 | MAX6871 |  |  |
| 1 | 3 | PO2 | Programmable Output 2. Configurable, active-high, active-low, open-drain, weak pullup, or charge-pump output. PO2 pulls low with a $10 \mu \mathrm{~A}$ internal current sink for $+1 \mathrm{~V}<\mathrm{V}_{\mathrm{ABP}}<\mathrm{V}_{\text {UVLO }}$. PO2 assumes its programmed conditional output state when ABP exceeds UVLO. |
| 2 | 5 | PO3 | Programmable Output 3. Configurable, active-high, active-low, open-drain, weak pullup (MAX6870), push-pull (MAX6871), or charge-pump (MAX6870) output. PO3 pulls low with a $10 \mu \mathrm{~A}$ internal current sink for +1 V < $\mathrm{V}_{\mathrm{ABP}}<\mathrm{V}_{\mathrm{AVLO}}$. PO3 assumes its programmed conditional output state when ABP exceeds UVLO. |
| 3 | 6 | PO4 | Programmable Output 4. Configurable, active-high, active-low, open-drain, weak pullup (MAX6870), push-pull (MAX6871), or charge-pump (MAX6870) output. PO4 pulls low with a $10 \mu \mathrm{~A}$ internal current sink for $+1 \mathrm{~V}<\mathrm{V}_{\mathrm{ABP}}<\mathrm{V}$ UVLO. PO4 assumes its programmed conditional output state when ABP exceeds UVLO. |
| 4 | 4 | GND | Ground |
| 5 | 7 | PO5 | Programmable Output 5. Configurable, active-high, active-low, open-drain, weak pullup, or push-pull output. PO5 pulls low with a $10 \mu \mathrm{~A}$ internal current sink for $+1 \mathrm{~V}<\mathrm{V}_{\text {ABP }}<\mathrm{V}_{\text {UVLO }}$. PO5 assumes its programmed conditional output state when ABP exceeds UVLO. |
| 6 | - | PO6 | Programmable Output 6. Configurable, active-high, active-low, open-drain, weak pullup, or push-pull output. PO6 pulls low with a $10 \mu \mathrm{~A}$ internal current sink for $+1 \mathrm{~V}<\mathrm{V}_{\text {ABP }}<\mathrm{V}_{\text {UVLO }}$. PO6 assumes its programmed conditional output state when ABP exceeds UVLO. |
| 7 | - | PO7 | Programmable Output 7. Configurable, active-high, active-low, open-drain, weak pullup, or push-pull output. PO7 pulls low with a $10 \mu \mathrm{~A}$ internal current sink for +1 V < VABP < VuVLo. PO7 assumes its programmed conditional output state when ABP exceeds UVLO. |
| 8 | - | PO8 | Programmable Output 8. Configurable, active-high, active-low, open-drain, weak pullup, or push-pull output. PO8 pulls low with a $10 \mu \mathrm{~A}$ internal current sink for $+1 \mathrm{~V}<\mathrm{V}_{\mathrm{ABP}}<\mathrm{V}_{\mathrm{V}}$ LO. PO8 assumes its programmed conditional output state when ABP exceeds UVLO. |
| 9, 10 | $\begin{aligned} & 1,8,9,10, \\ & 25,26,32 \end{aligned}$ | N.C. | No Connection. Not internally connected. |
| 11 | 11 | $\overline{\text { MARGIN }}$ | Margin Input. Configure $\overline{\text { MARGIN }}$ to either assert PO_ into a programmed state or to hold PO_ in its existing state when driving $\overline{\text { MARGIN }}$ low. See Table 8. Leave $\overline{\text { MARGIN }}$ unconnected or connect to DBP if unused. $\overline{\mathrm{MARGIN}}$ overrides $\overline{\mathrm{MR}}$ if both assert at the same time. $\overline{\mathrm{MARGIN}}$ is internally pulled up to DBP through a $10 \mu \mathrm{~A}$ current source. |
| 12 | 12 | $\overline{M R}$ | Manual Reset Input. Configure $\overline{M R}$ to either assert $\mathrm{PO}_{\mathrm{Z}}$ into a programmed state or to have no effect on PO_ when driving $\overline{M R}$ low. See Table 7. Leave $\overline{M R}$ unconnected or connect to DBP if unused. $\overline{\mathrm{MR}}$ is internally pulled up to DBP through a $10 \mu \mathrm{~A}$ current source. |
| 13 | 13 | SDA | Serial Data Input/Output (Open-Drain). SDA requires an external pullup resistor. |
| 14 | 14 | SCL | Serial Clock Input. SCL requires an external pullup resistor. |
| 15 | 15 | AO | Address Input 0. Address inputs allow up to four MAX6870/MAX6871 connections on one common bus. Connect A0 to GND or to the serial interface power supply. |
| 16 | 16 | A1 | Address Input 1. Address inputs allow up to four MAX6870/MAX6871 connections on one common bus. Connect A1 to GND or to the serial interface power supply. |

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

## Pin Description (continued)

| PIN |  | NAME | FUNCTION |
| :---: | :---: | :---: | :---: |
| MAX6870 | MAX6871 |  |  |
| 17 | 17 | GPI4 | General-Purpose Logic Input 4. An internal 10 1 A current source pulls GPI4 to GND. Configure GPI4 to control watchdog timer functions or the programmable outputs. |
| 18 | 18 | GPI3 | General-Purpose Logic Input 3. An internal 10hA current source pulls GPI3 to GND. Configure GPI3 to control watchdog timer functions or the programmable outputs. |
| 19 | 19 | GPI2 | General-Purpose Logic Input 2. An internal 10 1 A current source pulls GPI2 to GND. Configure GP12 to control watchdog timer functions or the programmable outputs. |
| 20 | 20 | GPI1 | General-Purpose Logic Input 1. An internal 10 1 A current source pulls GPI1 to GND. Configure GPI1 to control watchdog timer functions or the programmable outputs. |
| 21 | 21 | ABP | Internal Power-Supply Output. Bypass ABP to GND with a $1 \mu \mathrm{~F}$ ceramic capacitor. ABP powers the internal circuitry of the MAX6870/MAX6871. ABP supplies the input voltage to the internal charge pumps when the programmable outputs are configured as charge-pump outputs. Do not use ABP to supply power to external circuitry. |
| 22 | 22 | DBP | Internal Digital Power-Supply Output. Bypass DBP to GND with a $1 \mu$ F ceramic capacitor. DBP supplies power to the EEPROM memory and the internal logic circuitry. Do not use DBP to supply power to external circuitry. |
| 23 | 23 | AUXIN2 | Auxiliary Input 2. A 10-bit ADC monitors the input voltage at AUXIN2. The high-impedance AUXIN2 input accepts input voltages up to $V_{\text {REFIN. }}$. AUXIN2 does not influence EEPROMconfigurable power-supply sequencing or reset detection functions. |
| 24 | 24 | AUXIN1 | Auxiliary Input 1. A 10-bit ADC monitors the input voltage at AUXIN1. The high-impedance AUXIN1 input accepts input voltages up to $V_{\text {REFIN. AUXIN1 does not influence EEPROM- }}^{\text {A }}$ configurable power-supply sequencing or reset detection functions. |
| 25 | - | IN6 | Voltage Input 6 . Configure IN6 to detect voltage thresholds between +1 V and +5.5 V in 20 mV increments, or +0.5 V to +3.05 V in 10 mV increments. For improved noise immunity, bypass IN6 to GND with a 0.1 HF capacitor installed as close to the device as possible. |
| 26 | - | IN5 | Voltage Input 5 . Configure IN 5 to detect voltage thresholds between +1 V and +5.5 V in 20 mV increments, or +0.5 V to +3.05 V in 10 mV increments. For improved noise immunity, bypass IN5 to GND with a $0.1 \mu \mathrm{~F}$ capacitor installed as close to the device as possible. |
| 27 | 27 | IN4 | Voltage Input 4 . Configure IN4 to detect voltage thresholds between +1 V and +5.5 V in 20 mV increments, or +0.5 V to +3.05 V in 10 mV increments. For improved noise immunity, bypass IN4 to GND with a $0.1 \mu \mathrm{~F}$ capacitor installed as close to the device as possible. |
| 28 | 28 | IN3 | Voltage Input 3 . Configure IN3 to detect voltage thresholds between +1 V and +5.5 V in 20 mV increments, or +0.5 V to +3.05 V in 10 mV increments. For improved noise immunity, bypass IN3 to GND with a 0.1 HF capacitor installed as close to the device as possible. |
| 29 | 29 | IN2 | Bipolar Voltage Input 2. Configure IN2 to detect negative voltage thresholds from -2.5 V to -15.25 V in 50 mV increments or -1.25 V to -7.625 V in 25 mV increments. Alternatively, configure IN2 to detect positive voltage thresholds from +2.5 V to +15.25 V in 50 mV increments or +1.25 V to +7.625 V in 25 mV increments. For improved noise immunity, bypass IN2 to GND with a $0.1 \mu \mathrm{~F}$ capacitor installed as close to the device as possible. |

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

Pin Description (continued)

| PIN |  | NAME | FUNCTION |
| :---: | :---: | :---: | :---: |
| MAX6870 | MAX6871 |  |  |
| 30 | 30 | IN1 | High Voltage Input 1. Configure IN1 to detect voltage thresholds from +2.5 V to +13.2 V in 50 mV increments or +1.25 V to +7.625 V in 25 mV increments. For improved noise immunity, bypass IN1 to GND with a $0.1 \mu \mathrm{~F}$ capacitor installed as close to the device as possible. |
| 31 | 31 | REFIN | Reference Voltage Input. Configure the MAX6870/MAX6871 to use either an internal reference or external reference (see Table 9). When configured for an internal reference, leave REFIN unconnected. When configured for an external reference, connect a +1.225 V to +1.275 V reference to REFIN. |
| 32 | 2 | PO1 | Programmable Output 1. Configurable active-high, active-low, open-drain, weak pullup, or charge-pump output. PO1 pulls low with a weak $10 \mu \mathrm{~A}$ internal current sink for $+1 \mathrm{~V}<\mathrm{V}_{\text {ABP }}$ < VUVLO. PO1 assumes its programmed conditional output state when ABP exceeds UVLO. |
| - | - | EP | Exposed Paddle. Exposed paddle is internally connected to GND. |

## Detailed Description

The MAX6870/MAX6871 EEPROM-configurable, multivoltage supply sequencers/supervisors monitor several voltage-detector inputs, two auxiliary inputs and four general-purpose logic inputs, and feature programmable outputs for highly-configurable, power-supply sequencing applications. The MAX6870 features six voltage-detector inputs and eight programmable outputs, while the MAX6871 features four voltage-detector inputs and five programmable outputs. Manual reset and margin disable inputs simplify board-level testing during the manufacturing process. The MAX6870/ MAX6871 feature an accurate internal 1.25 V reference. For greater accuracy, connect an external +1.25 V reference to REFIN.
All voltage detectors provide two configurable thresholds for undervoltage/overvoltage or dual undervoltage detection. One high-voltage input (IN1) provides detector threshold voltages from +1.25 V to +7.625 V in 25 mV increments or +2.5 V to +13.2 V in 50 mV increments. A bipolar input (IN2) provides detector threshold voltages from $\pm 1.25 \mathrm{~V}$ to $\pm 7.625 \mathrm{~V}$ in 25 mV increments, or $\pm 2.5 \mathrm{~V}$ to $\pm 15.25 \mathrm{~V}$ in 50 mV increments. Positive inputs (IN3-IN6) provide detector threshold voltages from +0.5 V to +3.05 V in 10 mV increments, or +1.0 V to +5.5 V in 20 mV increments.

An internal 10-bit ADC monitors the voltage-detector inputs and two auxiliary inputs through a multiplexer that automatically sequences through all inputs every 200 ms . The host controller communicates with the MAX6870/MAX6871s' internal 4kb user EEPROM, configuration EEPROM, configuration registers, ADC registers, and fault registers through an SMBus $/ I^{2} \mathrm{C}$ compatible serial interface (see Figure 1).
Programmable output options include active-high, active-low, open-drain, weak pullup, push-pull, and charge pump. Select the charge-pump output feature to drive n-channel FETs for power-supply sequencing (see the Applications Information section). The outputs swing between 0 and ( V ABP +5 V ) when configured for charge-pump operation.
Program each output to assert on any voltage-detector input, general-purpose logic input, watchdog timer, manual reset, or other output stages. Programmable timing-delay blocks configure each output to wait between $25 \mu \mathrm{~s}$ and 1600 ms before deasserting. A fault register logs the conditions that caused each output to assert (undervoltage, overvoltage, manual reset, etc.).
The MAX6870/MAX6871 feature two watchdog timers, adding flexibility. Program each watchdog timer to assert one or more programmable outputs. Program each

## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC

watchdog timer to clear on a combination of one GPI_ input and one programmable output, one of the GPI_ inputs only, or one of the programmable outputs only. The initial and normal watchdog timeout periods are independently programmable from 6.25 ms to 102.4 s .
A virtual diode-ORing scheme selects the input that powers the MAX6870/MAX6871. The MAX6870/MAX6871
derive power from IN 1 if $\mathrm{V}_{\mathrm{IN} 1}>+6.5 \mathrm{~V}$ or from the highest voltage on IN3-IN6 if $\mathrm{V}_{\mathrm{IN}} 1<+2.7 \mathrm{~V}$. The power source cannot be determined if $+4 \mathrm{~V}<\mathrm{V}$ IN $1<+6.5 \mathrm{~V}$ and one of VIN3 through VIN6 > +2.7V. The programmable outputs maintain the correct programmed logic state for VABP > VUVLO. One of IN3 through IN6 must be greater than +2.7 V or IN 1 must be greater than +4 V for device operation.


Figure 1. Top Level Block Diagram

## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC

Functional Diagram


# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 


#### Abstract

Powering the MAX6870/MAX6871 The MAX6870/MAX6871 derive power from the positive voltage-detector inputs: IN1, or IN3-IN6. A virtual diodeORing scheme selects the positive input that supplies power to the device (see the Functional Diagram). IN1 must be at least +4 V or one of IN3-IN6 (MAX6870)/ IN3/IN4 (MAX6871) must be at least +2.7 V to ensure device operation. An internal LDO regulates IN1 down to +5.4 V . The highest input voltage on IN3-IN6 (MAX6870)/ IN3/IN4 (MAX6871) supplies power to the device, unless $\mathrm{V}_{\mathrm{IN}} 1 \geq+6.5 \mathrm{~V}$, in which case IN 1 supplies power to the device. For $+4 \mathrm{~V}<\mathrm{V}_{\mathrm{IN} 1}<+6.5 \mathrm{~V}$ and one of V IN3 through VIN6 > +2.7V, the input power source cannot be determined due to the dropout voltage of the LDO. Internal hysteresis ensures that the supply input that initially powered the device continues to power the device when multiple input voltages are within 50 mV of each other. ABP powers the analog circuitry; bypass ABP to GND with a $1 \mu \mathrm{~F}$ ceramic capacitor installed as close to the device as possible. The internal supply voltage, measured at ABP, equals the maximum of IN3-IN6 (MAX6870)/IN3/IN4 (MAX6871) if VIN1 $=0$, or equals +5.4 V when V IN1 $>+6.5 \mathrm{~V}$. Do not use ABP to provide power to external circuitry.


The MAX6870/MAX6871 also generate a digital supply voltage (DBP) for the internal logic circuitry and the EEPROM; bypass DBP to GND with a $1 \mu \mathrm{~F}$ ceramic capacitor installed as close to the device as possible. The nominal DBP output voltage is +2.55 V . Do not use DBP to provide power to external circuitry.

ADC
The MAX6870/MAX6871 feature an internal 10-bit ADC that monitors the voltage-detector inputs and auxiliary inputs through an internal multiplexer that sequences through all input voltages in 200ms. Registers 50h to 5Fh store the ADC data. Read the ADC data from the MAX6870/MAX6871 with the serial interface. The ADC strictly monitors input voltages and has no effect on power-supply sequencing, reset detection, or the programmable outputs.

## Inputs

The MAX6870/MAX6871 contain multiple logic and volt-age-detector inputs. Each voltage-detector input is simultaneously monitored for primary and secondary thresholds. The primary threshold must be an undervoltage threshold. The secondary threshold may be an undervoltage or overvoltage threshold. Table 1 summarizes these various inputs.

## Table 1. Programmable Features

| FEATURE | DESCRIPTION |
| :---: | :---: |
| High Voltage Input (IN1) | - Primary undervoltage threshold <br> - Secondary overvoltage or undervoltage threshold <br> - $\quad+2.5 \mathrm{~V}$ to +13.2 V threshold in 50 mV increments <br> - +1.25 V to +7.625 V threshold in 25 mV increments |
| Bipolar Voltage Input (IN2) | - Primary undervoltage threshold <br> - Secondary overvoltage or undervoltage threshold <br> - $\pm 2.5 \mathrm{~V}$ to $\pm 15.25 \mathrm{~V}$ threshold in 50 mV increments <br> - $\pm 1.25 \mathrm{~V}$ to $\pm 7.625 \mathrm{~V}$ threshold in 25 mV increments |
| Positive Voltage Input <br> IN3-IN6 (MAX6870) <br> IN3, IN4 (MAX6871) | - Primary undervoltage threshold <br> - Secondary overvoltage or undervoltage threshold <br> - $\quad+1 \mathrm{~V}$ to +5.5 V threshold in 20 mV increments <br> - +0.5 V to +3.05 V threshold in 10 mV increments |
| Programmable Outputs $\begin{aligned} & \text { PO1-PO4 (MAX6870), } \\ & \text { PO1, PO2 (MAX6871) } \end{aligned}$ | - Active high or active low <br> - Open-drain, weak pullup, or charge-pump output <br> - Weak pullup to IN3-IN6 (IN3 or IN4 for MAX6871) or ABP <br> - Dependent on $\overline{M R}, \overline{M A R G I N}$, IN_, GPI1-GPI4, WDI1 and WDI2, and/or PO_ <br> - Programmable timeout periods of $25 \mu \mathrm{~s}, 1.5625 \mathrm{~ms}, 6.25 \mathrm{~ms}, 25 \mathrm{~ms}, 50 \mathrm{~ms}, 200 \mathrm{~ms}, 400 \mathrm{~ms}$, or 1.6 s |
| Programmable Outputs PO5-PO8 (MAX6870), PO3, PO4, PO5 <br> (MAX6871) | - Active high or active low <br> - Open-drain, weak pullup, or push-pull output <br> - Weak pullup to IN3-IN6 (IN3 or IN4 for MAX6871) or ABP <br> - Push-pull to IN3-IN6 (IN3 or IN4 for MAX6871) <br> - Dependent on $\overline{M R}, \overline{M A R G I N}, ~ I N ., ~ G P I 1-G P I 4, ~ W D I 1 ~ a n d ~ W D I 2, ~ a n d / o r ~ I N ~ . ~$ <br> - Programmable timeout periods of $25 \mu \mathrm{~s}, 1.5625 \mathrm{~ms}, 6.25 \mathrm{~ms}, 25 \mathrm{~ms}, 50 \mathrm{~ms}, 200 \mathrm{~ms}, 400 \mathrm{~ms}$, or 1.6 s |

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

Table 1. Programmable Features (continued)

| FEATURE | DESCRIPTION |
| :---: | :---: |
| General-Purpose Logic Inputs (GPI1-GPI4) | - Active high or active low logic levels <br> - Configure GPI_ as inputs to watchdog timers or programmable output stages |
| Watchdog Timers | - Clear dependent on any combination of one GPI_ input and one programmable output, a GPI_ input only, or a programmable output only <br> - Initial watchdog timeout period of $6.25 \mathrm{~ms}, 25 \mathrm{~ms}, 100 \mathrm{~ms}, 400 \mathrm{~ms}, 1.6 \mathrm{~s}, 6.4 \mathrm{~s}, 25.6 \mathrm{~s}$, or 102.4 s <br> - Normal watchdog timeout period of $6.25 \mathrm{~ms}, 25 \mathrm{~ms}, 100 \mathrm{~ms}, 400 \mathrm{~ms}, 1.6 \mathrm{~s}, 6.4 \mathrm{~s}, 25.6 \mathrm{~s}$, or 102.4 s <br> - Watchdog enable/disable <br> - Initial watchdog timeout period enable/disable |
| Auxiliary Inputs (AUXIN1, AUXIN2) | - Monitored by the internal 10-bit ADC |
| Manual Reset Input ( $\overline{\mathrm{MR}}$ ) | - Forces $\mathrm{PO}_{-}$into the active output state when $\overline{\mathrm{MR}}=\mathrm{GND}$ <br> - PO_ deassert after $\overline{\mathrm{MR}}$ releases high and the PO_ timeout period expires <br> - PO_ cannot be a function of $\overline{M R}$ only |
| Margining Input (MARGIN) | - Holds $\mathrm{PO}_{-}$in existing state or asserts $\mathrm{PO}_{-}$to a programmed output state, independent of changes in monitored inputs or watchdog timers, when $\overline{\text { MARGIN }}=$ GND <br> - Overrides $\overline{\mathrm{MR}}$ when both assert at the same time |
| Reference Input (REFIN) | - Internal +1.25 V reference voltage <br> - Goes high-impedance when internal reference selected <br> - External reference voltage input from +1.225 V to +1.275 V <br> - Sets ADC voltage range |
| 10-Bit ADC* | - Monitors IN_, AUXIN1, and AUXIN2 <br> - Completes conversion of all eight inputs in 200 ms <br> - Reference voltage sets ADC range <br> - Read ADC data from SMBus $/{ }^{2} \mathrm{C}$ interface |
| Write Disable | - Locks user EEPROM based on PO_ |
| Configuration Lock | - Locks configuration EEPROM |

*ADC does not control programmable outputs.

Set the primary and secondary threshold voltages for each voltage-detector input with registers 00h-0Bh. Each primary threshold voltage must be an undervoltage threshold. Configure each secondary threshold voltage as an undervoltage or overvoltage threshold (see register OCh). Set the threshold range for each voltage detector with register ODh.

## High Voltage Input (IN1)

IN1 offers threshold voltages of +2.5 V to +13.2 V in 50 mV increments, or +1.25 V to +7.625 V in 25 mV increments. Use the following equations to set the threshold voltages for IN1:

$$
x=\frac{\mathrm{V}_{\mathrm{TH}}-2.5 \mathrm{~V}}{0.05 \mathrm{~V}} \text { for }+2.5 \mathrm{~V} \text { to }+13.2 \mathrm{~V} \text { range }
$$

$$
x=\frac{\mathrm{V}_{T H}-1.25 \mathrm{~V}}{0.025 \mathrm{~V}} \text { for }+1.25 \mathrm{~V} \text { to }+7.625 \mathrm{~V} \text { range }
$$

where $\mathrm{V}_{\mathrm{TH}}$ is the desired threshold voltage and x is the decimal code for the desired threshold (Table 2). For the +2.5 V to +13.2 V range, x must equal 214 or less, otherwise the threshold exceeds the maximum operating voltage of IN1.

Bipolar Voltage Input (IN2)
IN2 offers negative thresholds from -2.5 V to -15.25 V in 50 mV increments, or from -1.25 V to -7.625 V in 25 mV increments. Alternatively, IN2 offers positive thresholds from +2.5 V to +15.25 V in 50 mV increments, or +1.25 V to +7.625 V in 25 mV increments. Use the following equations to set the threshold voltages for IN2:

## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC

$$
\begin{aligned}
& x=\frac{-\left(V_{T H}-2.5 \mathrm{~V}\right)}{0.05 \mathrm{~V}} \text { for }-2.5 \mathrm{~V} \text { to }-15.25 \mathrm{~V} \text { range } \\
& x=\frac{-\left(\mathrm{V}_{T H}-1.25 \mathrm{~V}\right)}{0.025 \mathrm{~V}} \text { for }-1.25 \mathrm{~V} \text { to }-7.625 \mathrm{~V} \text { range } \\
& x=\frac{V_{T H}-2.5 \mathrm{~V}}{0.05 \mathrm{~V}} \text { for }+2.5 \mathrm{~V} \text { to }+15.25 \mathrm{~V} \text { range } \\
& x=\frac{V_{T H}-1.25 \mathrm{~V}}{0.025 \mathrm{~V}} \text { for }+1.25 \mathrm{~V} \text { to }+7.625 \mathrm{~V} \text { range }
\end{aligned}
$$

where $\mathrm{V}_{\mathrm{TH}}$ is the desired threshold voltage and x is the decimal code for the desired threshold (Table 3).

IN3-IN6
IN3-IN6 offer positive voltage detectors monitor voltages from +1 V to +5.5 V in 20 mV increments, or +0.5 V to +3.05 V in 10 mV increments. Use the following equations to set the threshold voltages for $\mathrm{IN}_{-}$:

$$
\begin{gathered}
x=\frac{\mathrm{V}_{T H}-1 \mathrm{~V}}{0.02 \mathrm{~V}} \text { for }+1 \mathrm{~V} \text { to }+5.5 \mathrm{~V} \text { range } \\
x=\frac{\mathrm{V}_{\mathrm{TH}}-0.5 \mathrm{~V}}{0.01 \mathrm{~V}} \text { for }+0.5 \mathrm{~V} \text { to }+3.05 \mathrm{~V} \text { range }
\end{gathered}
$$

where $\mathrm{V}_{\mathrm{TH}}$ is the desired threshold voltage and x is the decimal code for the desired threshold (Table 4). For the +1 V to +5.5 V range, $x$ must equal 225 or less, otherwise the threshold exceeds the maximum operating voltage of IN3-IN6.

## Table 2. IN1 Threshold Settings

| REGISTER <br> ADDRESS | EEPROM <br> MEMORY <br> ADDRESS | BIT <br> RANGE | DESCRIPTION |
| :---: | :---: | :---: | :--- |
| 00 h | 8000 h | $[7: 0]$ | IN1 primary undervoltage detector threshold (V1A) (see equations in the High Voltage Input <br> (IN1) section). |
| 06 h | 8006 h | $[7: 0]$ | IN1 secondary undervoltage/overvoltage detector threshold (V1B) (see equations in the <br> High Voltage Input (IN1) section). |
| 0 Ch | 800 Ch | $[0]$ | IN1 secondary overvoltage/undervoltage selection. <br> 0 = overvoltage threshold. 1 = undervoltage threshold. |
| 0 Dh | 800 Dh | $[0]$ | IN1 range selection. <br> $0=2.5 \mathrm{~V}$ to 13.2 V range in 50 mV increments. $1=1.25 \mathrm{~V}$ to 7.625 V range in 25 mV increments. |

Table 3. IN2 Threshold Settings

| REGISTER <br> ADDRESS | EEPROM <br> MEMORY <br> ADDRESS | BIT <br> RANGE | DESCRIPTION |
| :---: | :---: | :---: | :--- |
| 01 h | 8001 h | $[7: 0]$ | IN2 primary undervoltage detector threshold (V2A) (see equations in the Bipolar Voltage <br> Input (IN2) section). |
| 07 h | 8007 h | $[7: 0]$ | IN2 secondary undervoltage/overvoltage detector threshold (V2B) (see equations in the <br> Bipolar Voltage Input (IN2) section). |
| $0 C h$ | 800 Ch | $[1]$ | IN2 secondary overvoltage/undervoltage selection. <br> $0=$ overvoltage threshold. $1=$ undervoltage threshold. |
| 0 Ch | 800 Dh | $[7: 6]$ | IN2 range selection. <br> $00=-2.5 \mathrm{~V}$ to -15.25 V range in 50 mV increments. <br> $01=-1.25 \mathrm{~V}$ to -7.625 V range in 25 mV increments. <br> $10=+2.5 \mathrm{~V}$ to +15.25 V range in 50 mV increments. <br> $11=+1.25 \mathrm{~V}$ to +7.625 V range in 25 mV increments. |

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

Table 4. IN3-IN6 Threshold Settings

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT RANGE | DESCRIPTION |
| :---: | :---: | :---: | :---: |
| 02h | 8002h | [7:0] | IN3 primary undervoltage detector threshold (V3A) (see equations in the IN3-IN6 section). |
| 03h | 8003h | [7:0] | IN4 primary undervoltage detector threshold (V4A) (see equations in the IN3-IN6 section). |
| 04h | 8004h | [7:0] | IN5 (MAX6870 only) primary undervoltage detector threshold (V5A) (see equations in the IN3-IN6 section). |
| 05h | 8005h | [7:0] | IN6 (MAX6870 only) primary undervoltage detector threshold (V6A) (see equations in the IN3-IN6 section). |
| 08h | 8008h | [7:0] | IN3 secondary undervoltage/overvoltage detector threshold (V3B) (see equations in the IN3-IN6 section). |
| 09h | 8009h | [7:0] | IN4 secondary undervoltage/overvoltage detector threshold (V4B) (see equations in the IN3-IN6 section). |
| OAh | 800Ah | [7:0] | IN5 (MAX6870 only) secondary undervoltage/overvoltage detector threshold (V5B) (see equations in the IN3-IN6 section). |
| OBh | 800Bh | [7:0] | IN6 (MAX6870 only) secondary undervoltage/overvoltage detector threshold (V6B) (see equations in the IN3-IN6 section). |
| 0Ch | 800Ch | [2] | IN3 secondary overvoltage/undervoltage selection. $0=$ overvoltage threshold. $1=$ undervoltage threshold. |
|  |  | [3] | IN4 secondary overvoltage/undervoltage selection. $0=$ overvoltage threshold. $1=$ undervoltage threshold. |
|  |  | [4] | IN5 (MAX6870 only) secondary overvoltage/undervoltage selection. $0=$ overvoltage threshold. $1=$ undervoltage threshold. |
|  |  | [5] | IN6 (MAX6870 only) secondary overvoltage/undervoltage selection. $0=$ overvoltage threshold. $1=$ undervoltage threshold. |
|  |  | [7:6] | Not used. |
| ODh | 800Dh | [1] | IN3 range selection. $0=+1 \mathrm{~V}$ to +5.5 V range in 20 mV increments. $1=+0.5 \mathrm{~V}$ to +3.05 V range in 10 mV increments. |
|  |  | [2] | IN4 range selection. $0=+1 \mathrm{~V}$ to +5.5 V range in 20 mV increments. $1=+0.5 \mathrm{~V}$ to +3.05 V range in 10 mV increments. |
|  |  | [3] | IN5 (MAX6870 only) range selection. $0=+1 \mathrm{~V}$ to +5.5 V range in 20 mV increments. $1=+0.5 \mathrm{~V}$ to +3.05 V range in 10 mV increments. |
|  |  | [4] | IN6 (MAX6870 only) range selection. $0=+1 \mathrm{~V}$ to +5.5 V range in 20 mV increments. $1=+0.5 \mathrm{~V}$ to +3.05 V range in 10 mV increments. |
|  |  | [5] | Not used. |

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

## AUXIN1 and AUXIN2

The AUXIN1 and AUXIN2 high-impedance analog inputs are intended to monitor two additional system voltages not required for power-supply sequencing or reset purposes. The internal 10-bit ADC monitors AUXIN1 and AUXIN2 and stores the data in the ADC registers (Table

Table 5. ADC Registers for AUXIN1 and AUXIN2 (Read Only)

| REGISTER <br> ADDRESS | BIT <br> RANGE | DESCRIPTION |
| :---: | :---: | :--- |
| 5Ch | $[7: 0]$ | AUXIN1 measured value, 8 MSBs. |
| 5 Dh | $[1: 0]$ | AUXIN1 measured value, 2 LSBs. |
|  | $[7: 2]$ | Not used. |
| 5 Eh | $[7: 0]$ | AUXIN2 measured value, 8 MSBs. |
|  | $[1: 0]$ | AUXIN2 measured value, 2 LSBs. |
|  | $[7: 2]$ | Not used. |

## Table 6. GPI1-GPI4 Active Logic States

| REGISTER <br> ADDRESS | BIT <br> RANGE | DESCRIPTION |
| :---: | :---: | :--- |
| 3 Bh | $[0]$ | GPI1. $0=$ active low. 1 = active high. |
|  | $[1]$ | GPI2. $0=$ active low. 1 = active high. |
|  | $[2]$ | GPI3. $0=$ active low. 1 = active high. |
|  | $[3]$ | GPI4. $0=$ active low. $1=$ active high. |

5). AUXIN1 and AUXIN2 do not assert any of the programmable outputs. The AUXIN1 and AUXIN2 inputs accept power-supply voltages or other system voltages scaled to the +1.25 V ADC input voltage range.

GPI1-GPI4
The GPI1-GPI4 programmable logic inputs control power-supply sequencing (programmable outputs), reset/interrupt signaling, and watchdog functions (see the Configuring the Watchdog Timers (Registers 3Ch-3Fh) section). Configure GPI1-GPI4 for active-low or active-high logic (Table 6). GPI1-GPI4 internally pull down to GND through a $10 \mu \mathrm{~A}$ current sink.
$\overline{M R}$
The manual reset $(\overline{\mathrm{MR}})$ input initiates a reset condition. Register 40h determines the programmable outputs that assert while $\overline{\mathrm{MR}}$ is low (Table 7). All affected programmable outputs remain asserted (see the Programmable Outputs section) for their $\mathrm{PO}_{-}$timeout periods after $\overline{\mathrm{MR}}$ releases high. An internal $10 \mu \mathrm{~A}$ current source pulls $\overline{\mathrm{MR}}$ to DBP. Leave $\overline{M R}$ unconnected or connect to DBP if unused. A programmable output cannot depend solely on $\overline{M R}$.

Table 7. Programmable Output Behavior and $\overline{M R}$

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | $\begin{gathered} \text { BIT } \\ \text { RANGE } \end{gathered}$ | DESCRIPTION |
| :---: | :---: | :---: | :---: |
| 40h | 8040h | [0] | PO1 (MAX6870 only). $0=$ PO1 independent of $\overline{\mathrm{MR}} .1=\mathrm{PO1}$ asserts when $\overline{\mathrm{MR}}=$ low. |
|  |  | [1] | PO 2 (MAX6870 only). $0=\mathrm{PO} 2$ independent of $\overline{\mathrm{MR}} .1=\mathrm{PO} 2$ asserts when $\overline{\mathrm{MR}}=$ low. |
|  |  | [2] | PO3 (MAX6870)/PO1 (MAX6871). $0=\mathrm{PO} / \mathrm{PO} 1$ independent of $\overline{\mathrm{MR}}$. $1=\mathrm{PO} / \mathrm{PO} 1$ asserts when $\overline{\mathrm{MR}}=$ low. |
|  |  | [3] | PO4 (MAX6870)/PO2 (MAX6871). $0=\mathrm{PO} 4 / \mathrm{PO} 2$ independent of $\overline{\mathrm{MR}}$. $1=\mathrm{PO} 4 / \mathrm{PO} 2$ asserts when $\overline{\mathrm{MR}}=$ low. |
|  |  | [4] | PO5 (MAX6870)/PO3 (MAX6871). $0=\mathrm{PO5} / \mathrm{PO} 3$ independent of $\overline{\mathrm{MR}}$. $1=\mathrm{PO} 5 / \mathrm{PO} 3$ asserts when $\overline{\mathrm{MR}}=$ low. |
|  |  | [5] | PO6 (MAX6870)/PO4 (MAX6871). $0=\mathrm{PO6} / \mathrm{PO} 4$ independent of $\overline{\mathrm{MR}}$. $1=\mathrm{PO} / \mathrm{PO} 4$ asserts when $\overline{\mathrm{MR}}=$ low. |
|  |  | [6] | PO7 (MAX6870)/PO5 (MAX6871). $0=\mathrm{PO} / \mathrm{PO} 5$ independent of $\overline{\mathrm{MR}}$. $1=\mathrm{PO} / \mathrm{PO} 5$ asserts when $\overline{\mathrm{MR}}=$ low. |
|  |  | [7] | PO8 (MAX6870 only). $0=$ PO8 independent of $\overline{\mathrm{MR}} .1=\mathrm{PO8}$ asserts when $\overline{\mathrm{MR}}=$ low. |

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 


#### Abstract

$\overline{M A R G I N}$ $\overline{\text { MARGIN }}$ allows system-level testing while power supplies exceed the normal ranges. Registers 41 h and 42h determine whether the programmable outputs assert to a predetermined state or hold the last state as MARGIN is driven low (Table 8). Drive MARGIN low to set the programmable outputs in a known state while system-


level testing occurs. Leave $\overline{\text { MARGIN unconnected or }}$ connect to DBP if unused. An internal $10 \mu \mathrm{~A}$ current source pulls $\overline{\text { MARGIN }}$ to DBP. The internal ADC continually monitors $\mathrm{IN}_{-}$while MARGIN is low. The state of each programmable output does not change while $\overline{\text { MARGIN }}=$ GND. $\overline{\text { MARGIN }}$ overrides $\overline{\text { MR }}$ if both assert at the same time.

Table 8. Programmable Output Behavior and $\overline{\text { MARGIN }}$

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT RANGE | AFFECTED OUTPUT | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: |
| 41h | 8041h | [0] | $\begin{gathered} \text { PO1 } \\ \text { (MAX6870 only) } \end{gathered}$ | 0 = output held in existing state. <br> 1 = output asserts high or low (see 42h[0]). |
|  |  | [1] | $\begin{gathered} \text { PO2 } \\ \text { (MAX6870 only) } \end{gathered}$ | 0 = output held in existing state. <br> 1 = output asserts high or low (see 42h[1]). |
|  |  | [2] | $\begin{aligned} & \text { PO3 (MAX6870) } \\ & \text { PO1 (MAX6871) } \end{aligned}$ | $0=$ output held in existing state. <br> 1 = output asserts high or low (see 42h[2]). |
|  |  | [3] | $\begin{aligned} & \text { PO4 (MAX6870) } \\ & \text { PO2 (MAX6871) } \end{aligned}$ | $0=$ output held in existing state. <br> 1 = output asserts high or low (see 42h[3]). |
|  |  | [4] | PO5 (MAX6870) <br> PO3 (MAX6871) | $0=$ output held in existing state. <br> 1 = output asserts high or low (see 42h[4]). |
|  |  | [5] | PO6 (MAX6870) <br> PO4 (MAX6871) | 0 = output held in existing state. <br> 1 = output asserts high or low (see 42h[5]). |
|  |  | [6] | $\begin{aligned} & \text { PO7 (MAX6870) } \\ & \text { PO5 (MAX6871) } \end{aligned}$ | $0=$ output held in existing state. <br> 1 = output asserts high or low (see 42h[6]). |
|  |  | [7] | $\begin{gathered} \text { PO8 } \\ \text { (MAX6870 only) } \end{gathered}$ | $0=$ output held in existing state. <br> 1 = output asserts high or low (see 42h[7]). |
| 42h | 8042h | [0] | $\begin{gathered} \text { PO1 } \\ \text { (MAX6870 only) } \end{gathered}$ | $\begin{aligned} & 0=\text { output asserts low if } 41 \mathrm{~h}[0]=1 . \\ & 1=\text { output asserts high if } 41 \mathrm{~h}[0]=1 . \end{aligned}$ |
|  |  | [1] | $\begin{gathered} \text { PO2 } \\ \text { (MAX6870 only) } \end{gathered}$ | $\begin{aligned} & 0=\text { output asserts low if } 41 \mathrm{~h}[1]=1 . \\ & 1=\text { output asserts high if } 41 \mathrm{~h}[1]=1 . \end{aligned}$ |
|  |  | [2] | PO3 (MAX6870) <br> PO1 (MAX6871) | $\begin{aligned} & 0=\text { output asserts low if } 41 \mathrm{~h}[2]=1 . \\ & 1=\text { output asserts high if } 41 \mathrm{~h}[2]=1 . \end{aligned}$ |
|  |  | [3] | PO4 (MAX6870) <br> PO2 (MAX6871) | $\begin{aligned} & 0=\text { output asserts low if } 41 \mathrm{~h}[3]=1 . \\ & 1=\text { output asserts high if } 41 \mathrm{~h}[3]=1 . \end{aligned}$ |
|  |  | [4] | PO5 (MAX6870) <br> PO3 (MAX6871) | $\begin{aligned} & 0=\text { output asserts low if } 41 \mathrm{~h}[4]=1 . \\ & 1=\text { output asserts high if } 41 \mathrm{~h}[4]=1 . \end{aligned}$ |
|  |  | [5] | PO6 (MAX6870) <br> PO4 (MAX6871) | $\begin{aligned} & 0=\text { output asserts low if } 41 \mathrm{~h}[5]=1 . \\ & 1=\text { output asserts high if } 41 \mathrm{~h}[5]=1 . \end{aligned}$ |
|  |  | [6] | $\begin{aligned} & \text { PO7 (MAX6870) } \\ & \text { PO5 (MAX6871) } \end{aligned}$ | $\begin{aligned} & 0=\text { output asserts low if } 41 \mathrm{~h}[6]=1 . \\ & 1=\text { output asserts high if } 41 \mathrm{~h}[6]=1 . \end{aligned}$ |
|  |  | [7] | $\begin{gathered} \text { PO8 } \\ \text { (MAX6870 only) } \end{gathered}$ | $\begin{aligned} & 0=\text { output asserts low if } 41 \mathrm{~h}[7]=1 . \\ & 1=\text { output asserts high if } 41 \mathrm{~h}[7]=1 . \end{aligned}$ |

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 


#### Abstract

REFIN The MAX6870/MAX6871 feature an internal +1.25 V voltage reference. The voltage reference sets the threshold of the voltage detectors and provides a reference voltage for the internal ADC. Program register 44h to use the internal reference or an external reference (Table 9). Leave REFIN unconnected when using the internal reference. REFIN accepts an external reference in the +1.225 V to +1.275 V range.


## Table 9. Reference Register

| REGISTER <br> ADDRESS | EEPROM <br> MEMORY <br> ADDRESS | BIT <br> RANGE | DESCRIPTION |
| :---: | :---: | :---: | :--- |
| 44 h | 8044 h | $[0]$ | $0=$ internal reference. <br> $1=$ external reference |
|  | $[7: 1]$ | Not used. |  |

## Programmable Outputs

The MAX6870 features eight programmable outputs, while the MAX6871 features five programmable outputs. Selectable output-stage configurations include: active low or active high, open drain, weak pullup, push-pull, or charge pump. During power-up, the programmable outputs pull to GND with an internal 10رA current sink for 1 V < VABP < VUVLO. The programmable outputs remain in their active states until PO_ timeout period expires, and all of the programmed conditions are met for each output. Any output programmed to depend on no condition always remains in its active state (Table 22). An activehigh configured output is considered asserted when that output is logic-high. No output can depend solely on $\overline{\mathrm{MR}}$.
The positive voltage monitors generate fault signals (logical 0) to the MAX6870/MAX6871's logic array when an input voltage is below the programmed undervoltage threshold, or when that voltage is above the overvoltage threshold. The negative voltage monitor (IN2) generates a fault signal to the logic array when the input voltage is less negative than the undervoltage threshold, or when that voltage is more negative than the overvoltage threshold.

Registers 0Eh through 3Ah and 40h configure each of the programmable outputs. Programmable timing blocks set the PO_timeout period from $25 \mu \mathrm{~s}$ to 1600 ms for each programmable output. See register 3Ah (Table 22) to set the active state (active-high or active-low) for each programmable output and registers 11h, 15h, $1 \mathrm{Ch}, 23 \mathrm{~h}, 2 \mathrm{Ah}, 31 \mathrm{~h}, 35 \mathrm{~h}$, and 39 h to select the output stage types (Tables 23 and 24), and PO_ timeout periods (Table 25) for each output.
Control selected programmable outputs with a sum of products (Tables 10-21). Each product allows a different set of conditions to assert each output. Outputs PO3 (MAX6870)/PO1 (MAX6871) and PO6 (MAX6870)/ PO4 (MAX6871) allow two sets of different conditions to assert each output. Outputs PO1 and PO2 (MAX6870 only), PO7 (MAX6870)/PO5 (MAX6871), and PO8 (MAX6870 only) allow only one set of conditions to assert each output.
For example, Product 1 of the PO3 (MAX6870-Table 12) programmable output may depend on the IN1 primary undervoltage threshold, and the states of GPI1, PO1, and PO2. Write a one to R16h[0], R17h[6], and R18h[3:2] to configure Product 1 as indicated. IN1 must be above the primary undervoltage threshold (Table 2), GPI1 must be inactive (Table 6), and PO1 (Tables 10 and 22) and PO2 (Tables 12 and 23) must be in their deasserted states for Product 1 to be a logical 1. Product 1 is equivalent to the logic statement: V1A • GPI1 • PO1 • PO2.
Product 2 of PO3 (MAX6870, Table 13) may depend on an entirely different set of conditions, or the same conditions, depending on the system requirements. For example, Product 2 may depend on the IN1 undervoltage threshold, and the states of GPI2 and WDI1. Write ones to R19h[6, 0] and R1Ah[7] to configure Product 2 as indicated. IN1 must be above the primary undervoltage threshold (Table 2), GPI2 must be inactive (Table 6), and the WDI1 timer must not have expired (Tables 27 and 28) for Product 2 to be a logical 1. Product 2 is equivalent to the logic statement: V1A - GPI2 - WDI1. PO3 deasserts if either Product 1 or Product 2 is a logical 1. The logical statement: Product $1+$ Product 2 determines the state of PO 3 .

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

Table 10. PO1 (MAX6870 Only) Output Dependency

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| OEh | 800Eh | [0] | 1 = PO1 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO1 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO1 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO1 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO1 assertion depends on IN5 primary undervoltage threshold (Table 4). |
|  |  | [5] | 1 = PO1 assertion depends on IN6 primary undervoltage threshold (Table 4). |
|  |  | [6] | 1 = PO1 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO1 assertion depends on watchdog 2 (Tables 27 and 28). |
| OFh | 800Fh | [0] | 1 = PO1 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO1 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO1 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO1 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO1 assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [5] | 1 = PO1 assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [6] | 1 = PO1 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO1 assertion depends on GPI2 (Table 6). |
| 10h | 8010h | [0] | 1 = PO1 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO1 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO1 assertion depends on PO2 (Table 11). |
|  |  | [3] | 1 = PO1 assertion depends on PO3 (Tables 12 and 13). |
|  |  | [4] | 1 = PO1 assertion depends on PO4 (Tables 14 and 15). |
|  |  | [5] | 1 = PO1 assertion depends on PO5 (Tables 16 and 17). |
|  |  | [6] | 1 = PO1 assertion depends on PO6 (Tables 18 and 19). |
|  |  | [7] | 1 = PO1 assertion depends on PO7 (Table 20). |
| 11h | 8011h | [0] | 1 = PO1 assertion depends on PO8 (Table 21). |
| 40h | 8040h | [0] | 1 = PO1 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 10 only applies to PO1 of the MAX6870. Write a 0 to a bit to make the PO1 output independent of the respective signal (IN1-IN6 primary or secondary
thresholds, WDI1 or WDI2, GPI1-GPI4, $\overline{\mathrm{MR}}$, or other programmable outputs).

## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC

Table 11. PO2 (MAX6870 Only) Output Dependency

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 12h | 8012h | [0] | 1 = PO2 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO2 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO2 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO2 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO2 assertion depends on IN5 primary undervoltage threshold (Table 4). |
|  |  | [5] | 1 = PO2 assertion depends on IN6 primary undervoltage threshold (Table 4). |
|  |  | [6] | 1 = PO2 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO2 assertion depends on watchdog 2 (Tables 27 and 28). |
| 13h | 8013h | [0] | 1 = PO2 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO2 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO2 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO2 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO2 assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [5] | 1 = PO2 assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [6] | 1 = PO2 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO2 assertion depends on GPI2 (Table 6). |
| 14h | 8014h | [0] | 1 = PO2 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO2 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO2 assertion depends on PO1 (Table 10). |
|  |  | [3] | 1 = PO2 assertion depends on PO3 (Tables 12 and 13). |
|  |  | [4] | 1 = PO2 assertion depends on PO4 (Tables 14 and 15). |
|  |  | [5] | 1 = PO2 assertion depends on PO5 (Tables 16 and 17). |
|  |  | [6] | 1 = PO2 assertion depends on PO6 (Tables 18 and 19). |
|  |  | [7] | 1 = PO2 assertion depends on PO7 (Table 20). |
| 15h | 8015h | [0] | 1 = PO2 assertion depends on PO8 (Table 21). |
| 40h | 8040h | [1] | 1 = PO2 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 11 only applies to PO2 of the MAX6870. Write a 0 to a bit to make the PO2 output independent of the respective signal (IN1-IN6 primary or secondary
thresholds, WDI1 or WDI2, GPI1-GPI4, $\overline{\mathrm{MR}}$, or other programmable outputs).

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

Table 12. PO3 (MAX6870)/PO1 (MAX6871) Output Dependency (Product 1)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 16h | 8016h | [0] | 1 = PO3/PO1 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO3/PO1 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO3/PO1 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO3/PO1 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO3 (MAX6870 only) assertion depends on IN5 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO3 (MAX6870 only) assertion depends on IN6 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO3/PO1 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO3/PO1 assertion depends on watchdog 2 (Tables 27 and 28). |
| 17h | 8017h | [0] | 1 = PO3/PO1 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO3/PO1 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO3/PO1 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO3/PO1 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO3 (MAX6870 only) assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO3 (MAX6870 only) assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO3/PO1 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO3/PO1 assertion depends on GPI2 (Table 6). |
| 18h | 8018h | [0] | 1 = PO3/PO1 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO3/PO1 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO3 (MAX6870 only) assertion depends on PO1 (Table 10). Must be set to 0 for the MAX6871. |
|  |  | [3] | 1 = PO3 (MAX6870 only) assertion depends on PO2 (Table 11). Must be set to 0 for the MAX6871. |
|  |  | [4] | 1 = PO3/PO1 assertion depends on PO4 (MAX6870)/PO2 (MAX6871) (Tables 14 and 15). |
|  |  | [5] | 1 = PO3/PO1 assertion depends on PO5 (MAX6870)/PO3 (MAX6871) (Tables 16 and 17). |
|  |  | [6] | 1 = PO3/PO1 assertion depends on PO6 (MAX6870)/PO4 (MAX6871) (Tables 18 and 19). |
|  |  | [7] | 1 = PO3/PO1 assertion depends on PO7 (MAX6870)/PO5 (MAX6871) (Table 20). |
| 1Ch | 801Ch | [0] | 1 = PO3 (MAX6870 only) assertion depends on PO8 (Table 21). Must be set to 0 for the MAX6871. |
| 40h | 8040h | [2] | 1 = PO3/PO1 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 12 only applies to PO3 of the MAX6870 and PO1 of the MAX6871. Write a 0 to a bit to make the PO3/PO1 output independent of the respective signal (IN_ primary or secondary thresholds, WDI1 or WDI2, GPI1-GPI4,
$\overline{\mathrm{MR}}$, or other programmable outputs). See Table 13 for Product 2. PO3 (MAX6870)/PO1 (MAX6871) deasserts when Product 1 or Product $2=1$.

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

Table 13. PO3 (MAX6870)/PO1 (MAX6871) Output Dependency (Product 2)

| $\begin{array}{c}\text { REGISTER } \\ \text { ADDRESS }\end{array}$ | $\begin{array}{c}\text { EEPROM } \\ \text { MEMORY } \\ \text { ADDRESS }\end{array}$ | BIT |  | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :--- | :--- |$]$

Table 13 only applies to PO3 of the MAX6870 and PO1 of the MAX6871. Write a 0 to a bit to make the PO3/PO1 output independent of the respective signal (IN_ primary or secondary thresholds, WDI1 or WDI2, GPI1-GPI4,
$\overline{\mathrm{MR}}$, or other programmable outputs). See Table 12 for Product 1. PO3 (MAX6870)/PO1 (MAX6871) deasserts when Product 1 or Product $2=1$.

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

Table 14. PO4 (MAX6870)/PO2 (MAX6871) Output Dependency (Product 1)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 1Dh | 801Dh | [0] | 1 = PO4/PO2 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO4/PO2 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO4/PO2 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO4/PO2 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO4 (MAX6870 only) assertion depends on IN5 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO4 (MAX6870 only) assertion depends on IN6 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO4/PO2 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO4/PO2 assertion depends on watchdog 2 (Tables 27 and 28). |
| 1Eh | 801Eh | [0] | 1 = PO4/PO2 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO4/PO2 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO4/PO2 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO4/PO2 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO4 (MAX6870 only) assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO4 (MAX6870 only) assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO4/PO2 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO4/PO2 assertion depends on GPI2 (Table 6). |
| 1Fh | 801Fh | [0] | 1 = PO4/PO2 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO4/PO2 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO4 (MAX6870 only) assertion depends on PO1 (Table 10). Must be set to 0 for the MAX6871. |
|  |  | [3] | 1 = PO4 (MAX6870 only) assertion depends on PO2 (Table 11). Must be set to 0 for the MAX6871. |
|  |  | [4] | 1 = PO4/PO2 assertion depends on PO3 (MAX6870)/PO1 (MAX6871) (Tables 12 and 13). |
|  |  | [5] | 1 = PO4/PO2 assertion depends on PO5 (MAX6870)/PO3 (MAX6871) (Tables 16 and 17). |
|  |  | [6] | 1 = PO4/PO2 assertion depends on PO6 (MAX6870)/PO4 (MAX6871) (Tables 18 and 19). |
|  |  | [7] | 1 = PO4/PO2 assertion depends on PO7 (MAX6870)/PO5 (MAX6871) (Table 20). |
| 23h | 8023h | [0] | 1 = PO4 (MAX6870 only) assertion depends on PO8 (Table 21). Must be set to 0 for the MAX6871. |
| 40h | 8040h | [3] | 1 = PO4/PO2 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 14 only applies to PO4 of the MAX6870 and PO2 of the MAX6871. Write a 0 to a bit to make the PO4/PO2 output independent of the respective signal (IN_ primary or secondary thresholds, WDI1 or WDI2, GPI1-GPI4,
$\overline{\mathrm{MR}}$, or other programmable outputs). See Table 15 for Product 2. PO4 (MAX6870)/PO2 (MAX6871) deasserts when Product 1 or Product $2=1$.

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

Table 15. PO4 (MAX6870)/PO2 (MAX6871) Output Dependency (Product 2)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 20h | 8020h | [0] | 1 = PO4/PO2 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO4/PO2 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO4/PO2 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO4/PO2 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO4 (MAX6870 only) assertion depends on IN5 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO4 (MAX6870 only) assertion depends on IN6 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO4/PO2 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO4/PO2 assertion depends on watchdog 2 (Tables 27 and 28). |
| 21h | 8021h | [0] | 1 = PO4/PO2 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO4/PO2 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO4/PO2 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO4/PO2 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO4 (MAX6870 only) assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO4 (MAX6870 only) assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO4/PO2 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO4/PO2 assertion depends on GPI2 (Table 6). |
| 22h | 8022h | [0] | 1 = PO4/PO2 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO4/PO2 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO4 (MAX6870 only) assertion depends on PO1 (Table 10). Must be set to 0 for the MAX6871. |
|  |  | [3] | 1 = PO4 (MAX6870 only) assertion depends on PO2 (Table 11). Must be set to 0 for the MAX6871. |
|  |  | [4] | 1 = PO4/PO2 assertion depends on PO3 (MAX6870)/PO1 (MAX6871) (Tables 12 and 13). |
|  |  | [5] | 1 = PO4/PO2 assertion depends on PO5 (MAX6870)/PO3 (MAX6871) (Tables 16 and 17). |
|  |  | [6] | 1 = PO4/PO2 assertion depends on PO6 (MAX6870)/PO4 (MAX6871) (Tables 18 and 19). |
|  |  | [7] | 1 = PO4/PO2 assertion depends on PO7 (MAX6870)/PO5 (MAX6871) (Table 20). |
| 23h | 8023h | [1] | 1 = PO4 (MAX6870 only) assertion depends on PO8 (Table 21). Must be set to 0 for the MAX6871. |
| 40h | 8040h | [3] | 1 = PO4/PO2 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 15 only applies to PO4 of the MAX6870 and PO2 of the MAX6871. Write a 0 to a bit to make the PO4/PO2 output independent of the respective signal (IN_ primary or secondary thresholds, WDI1 or WDI2, GPI1 to GPI4,
$\overline{\mathrm{MR}}$, or other programmable outputs). See Table 14 for Product 1. PO4 (MAX6870)/PO2 (MAX6871) deasserts when Product 1 or Product $2=1$.

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

Table 16. PO5 (MAX6870)/PO3 (MAX6871) Output Dependency (Product 1)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 24h | 8024h | [0] | 1 = PO5/PO3 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO5/PO3 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO5/PO3 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO5/PO3 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO5 (MAX6870 only) assertion depends on IN5 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO5 (MAX6870 only) assertion depends on IN6 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO5/PO3 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO5/PO3 assertion depends on watchdog 2 (Tables 27 and 28). |
| 25h | 8025h | [0] | 1 = PO5/PO3 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO5/PO3 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO5/PO3 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO5/PO3 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO5 (MAX6870 only) assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO5 (MAX6870 only) assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO5/PO3 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO5/PO3 assertion depends on GPI2 (Table 6). |
| 26h | 8026h | [0] | 1 = PO5/PO3 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO5/PO3 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO5 (MAX6870 only) assertion depends on PO1 (Table 10). Must be set to 0 for the MAX6871. |
|  |  | [3] | 1 = PO5 (MAX6870 only) assertion depends on PO2 (Table 11). Must be set to 0 for the MAX6871. |
|  |  | [4] | 1 = PO5/PO3 assertion depends on PO3 (MAX6870)/PO1 (MAX6871) (Tables 12 and 13). |
|  |  | [5] | 1 = PO5/PO3 assertion depends on PO4 (MAX6870)/PO2 (MAX6871) (Tables 14 and 15). |
|  |  | [6] | 1 = PO5/PO3 assertion depends on PO6 (MAX6870)/PO4 (MAX6871) (Tables 18 and 19). |
|  |  | [7] | 1 = PO5/PO3 assertion depends on PO7 (MAX6870)/PO5 (MAX6871) (Table 20). |
| 2Ah | 802Ah | [0] | 1 = PO5 (MAX6870 only) assertion depends on PO8 (Table 21). Must be set to 0 for the MAX6871. |
| 40h | 8040h | [4] | 1 = PO5/PO3 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 16 only applies to PO5 of the MAX6870 and PO3 of the MAX6871. Write a 0 to a bit to make the PO5/PO3 output independent of the respective signal (IN_ primary or secondary thresholds, WDI1 or WDI2, GPI1-GPI4,
$\overline{\mathrm{MR}}$, or other programmable outputs). See Table 17 for Product 2. PO5 (MAX6870)/PO3 (MAX6871) deasserts when Product 1 or Product $2=1$.

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

Table 17. PO5 (MAX6870)/PO3 (MAX6871) Output Dependency (Product 2)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 27h | 8027h | [0] | 1 = PO5/PO3 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO5/PO3 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = $\mathrm{PO} / \mathrm{PO} 3$ assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO5/PO3 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO5 (MAX6870 only) assertion depends on IN5 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO5 (MAX6870 only) assertion depends on IN6 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO5/PO3 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO5/PO3 assertion depends on watchdog 2 (Tables 27 and 28). |
| 28h | 8028h | [0] | 1 = PO5/PO3 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO5/PO3 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO5/PO3 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO5/PO3 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO5 (MAX6870 only) assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO5 (MAX6870 only) assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO5/PO3 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO5/PO3 assertion depends on GPI2 (Table 6). |
| 29h | 8029h | [0] | 1 = PO5/PO3 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO5/PO3 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO5 (MAX6870 only) assertion depends on PO1 (Table 10). Must be set to 0 for the MAX6871. |
|  |  | [3] | 1 = PO5 (MAX6870 only) assertion depends on PO2 (Table 11). Must be set to 0 for the MAX6871. |
|  |  | [4] | 1 = PO5/PO3 assertion depends on PO3 (MAX6870)/PO1 (MAX6871) (Tables 12 and 13). |
|  |  | [5] | 1 = PO5/PO3 assertion depends on PO4 (MAX6870)/PO2 (MAX6871) (Tables 14 and 15). |
|  |  | [6] | 1 = PO5/PO3 assertion depends on PO6 (MAX6870)/PO4 (MAX6871) (Tables 18 and 19). |
|  |  | [7] | 1 = PO5/PO3 assertion depends on PO7 (MAX6870)/PO5 (MAX6871) (Table 20). |
| 3Bh | 803Bh | [4] | 1 = PO5 (MAX6870 only) assertion depends on PO8 (Table 21). Must be set to 0 for the MAX6871. |
| 40h | 8040h | [4] | 1 = PO5/PO3 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 17 only applies to PO5 of the MAX6870 and PO3 of the MAX6871. Write a 0 to a bit to make the $\mathrm{PO} / \mathrm{PO} 3$ output independent of the respective signal (IN_ primary or secondary thresholds, WDI1 or WDI2, GPI1-GPI4,
$\overline{\mathrm{MR}}$, or other programmable outputs). See Table 16 for Product 1. PO5 (MAX6870)/PO3 (MAX6871) deasserts when Product 1 or Product $2=1$.

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

Table 18. PO6 (MAX6870)/PO4 (MAX6871) Output Dependency (Product 1)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 2Bh | 802Bh | [0] | 1 = PO6/PO4 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO6/PO4 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO6/PO4 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO6/PO4 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO6 (MAX6870 only) assertion depends on IN5 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO6 (MAX6870 only) assertion depends on IN6 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO6/PO4 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO6/PO4 assertion depends on watchdog 2 (Tables 27 and 28). |
| 2Ch | 802Ch | [0] | 1 = PO6/PO4 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO6/PO4 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO6/PO4 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO6/PO4 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO6 (MAX6870 only) assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO6 (MAX6870 only) assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO6/PO4 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO6/PO4 assertion depends on GPI2 (Table 6). |
| 2Dh | 802Dh | [0] | 1 = PO6/PO4 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO6/PO4 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO6 (MAX6870 only) assertion depends on PO1 (Table 10). Must be set to 0 for the MAX6871. |
|  |  | [3] | 1 = PO6 (MAX6870 only) assertion depends on PO2 (Table 11). Must be set to 0 for the MAX6871. |
|  |  | [4] | 1 = PO6/PO4 assertion depends on PO3 (MAX6870)/PO1 (MAX6871) (Tables 12 and 13). |
|  |  | [5] | 1 = PO6/PO4 assertion depends on PO4 (MAX6870)/PO2 (MAX6871) (Tables 14 and 15). |
|  |  | [6] | 1 = PO6/PO4 assertion depends on PO5 (MAX6870)/PO3 (MAX6871) (Tables 16 and 17). |
|  |  | [7] | 1 = PO6/PO4 assertion depends on PO7 (MAX6870)/PO5 (MAX6871) (Table 20). |
| 31h | 8031h | [0] | 1 = PO6 (MAX6870 only) assertion depends on PO8 (Table 21). Must be set to 0 for the MAX6871. |
| 40h | 8040h | [5] | 1 = PO6/PO4 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 18 only applies to PO6 of the MAX6870 and PO4 of the MAX6871. Write a 0 to a bit to make the PO6/PO4 output independent of the respective signal (IN_ primary or secondary thresholds, WDI1 or WDI2, GPI1-GPI4,
$\overline{\mathrm{MR}}$, or other programmable outputs). See Table 19 for Product 2. PO6 (MAX6870)/PO4 (MAX6871) deasserts when Product 1 or Product $2=1$.

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

Table 19. PO6 (MAX6870)/PO4 (MAX6871) Output Dependency (Product 2)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 2Eh | 802Eh | [0] | 1 = PO6/PO4 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO6/PO4 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO6/PO4 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO6/PO4 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO6 (MAX6870 only) assertion depends on IN5 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO6 (MAX6870 only) assertion depends on IN6 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO6/PO4 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO6/PO4 assertion depends on watchdog 2 (Tables 27 and 28). |
| 2Fh | 802Fh | [0] | 1 = PO6/PO4 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO6/PO4 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO6/PO4 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO6/PO4 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO6 (MAX6870 only) assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO6 (MAX6870 only) assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO6/PO4 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO6/PO4 assertion depends on GPI2 (Table 6). |
| 30h | 8030h | [0] | 1 = PO6/PO4 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO6/PO4 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO6 (MAX6870 only) assertion depends on PO1 (Table 10). Must be set to 0 for the MAX6871. |
|  |  | [3] | 1 = PO6 (MAX6870 only) assertion depends on PO2 (Table 11). Must be set to 0 for the MAX6871. |
|  |  | [4] | 1 = PO6/PO4 assertion depends on PO3 (MAX6870)/PO1 (MAX6871) (Tables 12 and 13). |
|  |  | [5] | 1 = PO6/PO4 assertion depends on PO4 (MAX6870)/PO2 (MAX6871) (Tables 14 and 15). |
|  |  | [6] | 1 = PO6/PO4 assertion depends on PO5 (MAX6870)/PO3 (MAX6871) (Tables 16 and 17). |
|  |  | [7] | 1 = PO6/PO4 assertion depends on PO7 (MAX6870)/PO5 (MAX6871) (Table 20). |
| 3Bh | 803Bh | [5] | 1 = PO6 (MAX6870 only) assertion depends on PO8 (Table 21). Must be set to 0 for the MAX6871. |
| 40h | 8040h | [5] | 1 = PO6/PO4 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 19 only applies to PO6 of the MAX6870 and PO4 of the MAX6871. Write a 0 to a bit to make the PO6/PO4 output independent of the respective signal (IN_ primary or secondary thresholds, WDI1 or WDI2, GPI1-GPI4,
$\overline{\mathrm{MR}}$, or other programmable outputs). See Table 18 for Product 1. PO6 (MAX6870)/PO4 (MAX6871) deasserts when Product 1 or Product $2=1$.

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

Table 20. PO7 (MAX6870)/PO5 (MAX6871) Output Dependency

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 32h | 8032h | [0] | 1 = PO7/PO5 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO7/PO5 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO7/PO5 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO7/PO5 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO7 (MAX6870 only) assertion depends on IN5 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO7 (MAX6870 only) assertion depends on IN6 primary undervoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO7/PO5 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO7/PO5 assertion depends on watchdog 2 (Tables 27 and 28). |
| 33h | 8033h | [0] | 1 = PO7/PO5 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO7/PO5 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO7/PO5 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO7/PO5 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO7 (MAX6870 only) assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [5] | 1 = PO7 (MAX6870 only) assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). Must be set to 0 for the MAX6871. |
|  |  | [6] | 1 = PO7/PO5 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO7/PO5 assertion depends on GPI2 (Table 6). |
| 34h | 8034h | [0] | 1 = PO7/PO5 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO7/PO5 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO7 (MAX6870 only) assertion depends on PO1 (Table 10). Must be set to 0 for the MAX6871. |
|  |  | [3] | 1 = PO7 (MAX6870 only) assertion depends on PO2 (Table 11). Must be set to 0 for the MAX6871. |
|  |  | [4] | 1 = PO7/PO5 assertion depends on PO3 (MAX6870)/PO1 (MAX6871) (Tables 12 and 13). |
|  |  | [5] | 1 = PO7/PO5 assertion depends on PO4 (MAX6870)/PO2 (MAX6871) (Tables 14 and 15). |
|  |  | [6] | 1 = PO7/PO5 assertion depends on PO5 (MAX6870)/PO3 (MAX6871) (Tables 16 and 17). |
|  |  | [7] | 1 = PO7/PO5 assertion depends on PO6 (MAX6870)/PO4 (MAX6871) (Tables 18 and 19). |
| 35h | 8035h | [0] | 1 = PO7 (MAX6870 only) assertion depends on PO8 (Table 21). Must be set to 0 for the MAX6871. |
| 40h | 8040h | [6] | 1 = PO7 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 20 only applies to PO7 of the MAX6870 and PO5 of the MAX6871. Write a 0 to a bit to make the PO7/PO5 output independent of the respective signal (IN_ primary
or secondary thresholds, WDI1 or WDI2, GPI1-GPI4, $\overline{\mathrm{MR}}$, or other programmable outputs).

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

Table 21. PO8 (MAX6870 only) Output Dependency

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT | OUTPUT ASSERTION CONDITIONS |
| :---: | :---: | :---: | :---: |
| 36h | 8036h | [0] | 1 = PO8 assertion depends on IN1 primary undervoltage threshold (Table 2). |
|  |  | [1] | 1 = PO8 assertion depends on IN2 primary undervoltage threshold (Table 3). |
|  |  | [2] | 1 = PO8 assertion depends on IN3 primary undervoltage threshold (Table 4). |
|  |  | [3] | 1 = PO8 assertion depends on IN4 primary undervoltage threshold (Table 4). |
|  |  | [4] | 1 = PO8 assertion depends on IN5 primary undervoltage threshold (Table 4). |
|  |  | [5] | 1 = PO8 assertion depends on IN6 primary undervoltage threshold (Table 4). |
|  |  | [6] | 1 = PO8 assertion depends on watchdog 1 (Tables 27 and 28). |
|  |  | [7] | 1 = PO8 assertion depends on watchdog 2 (Tables 27 and 28). |
| 37h | 8037h | [0] | 1 = PO8 assertion depends on IN1 secondary undervoltage/overvoltage threshold (Table 2). |
|  |  | [1] | 1 = PO8 assertion depends on IN2 secondary undervoltage/overvoltage threshold (Table 3). |
|  |  | [2] | 1 = PO8 assertion depends on IN3 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [3] | 1 = PO8 assertion depends on IN4 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [4] | 1 = PO8 assertion depends on IN5 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [5] | 1 = PO8 assertion depends on IN6 secondary undervoltage/overvoltage threshold (Table 4). |
|  |  | [6] | 1 = PO8 assertion depends on GPI1 (Table 6). |
|  |  | [7] | 1 = PO8 assertion depends on GPI2 (Table 6). |
| 38h | 8038h | [0] | 1 = PO8 assertion depends on GPI3 (Table 6). |
|  |  | [1] | 1 = PO8 assertion depends on GPI4 (Table 6). |
|  |  | [2] | 1 = PO8 assertion depends on PO1 (Table 10). |
|  |  | [3] | 1 = PO8 assertion depends on PO2 (Table 11). |
|  |  | [4] | 1 = PO8 assertion depends on PO3 (Tables 12 and 13). |
|  |  | [5] | 1 = PO8 assertion depends on PO4 (Tables 14 and 15). |
|  |  | [6] | 1 = PO8 assertion depends on PO5 (Tables 16 and 17). |
|  |  | [7] | 1 = PO8 assertion depends on PO6 (Tables 18 and 19). |
| 39h | 8039h | [0] | 1 = PO8 assertion depends on PO7 (Table 20). |
| 40h | 8040h | [7] | 1 = PO8 asserts when $\overline{\mathrm{MR}}=$ low (Table 7). |

Table 21 only applies to PO8 of the MAX6870. Write a 0 to a bit to make the PO8 output independent of the respective signal (IN1-IN6 primary or secondary thresholds, WDI1 or WDI2, GPI1-GPI4, $\overline{\mathrm{MR}}$, or other programmable outputs).

## Output Stage Configurations

Independently program each programmable output as active-high or active-low (Table 22). Additionally, program each programmable output as weak pullup, pushpull, open-drain, or charge pump (Tables 23 and 24). Every programmable output can be configured as open-drain or weak pullup; however, only PO1-PO4 (MAX6870) or PO1/PO2 (MAX6871) can be configured
as charge-pump outputs, and only PO5-PO8 (MAX6870) or PO3/PO4/PO5 (MAX6871) can be configured as push-pull outputs. Finally, set the $\mathrm{PO}_{-}$timeout period for each programmable output (Table 25).
An internal $10 \mathrm{k} \Omega$ resistor provides the pullup resistance for outputs configured as weak pullup stages. Program each weak pullup output stage to refer to ABP or one of the IN3-IN6 inputs. The programmable outputs source up to 10 mA and sink up to 4 mA when configured as pushpull stages. Program each push-pull output stage to reference to one of IN3-IN6. PO1-PO4 (MAX6870)/ PO1/P02 (MAX6871) pull to VABP +5 V when configured as charge-pump outputs.

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

## Table 22. Programmable Output Active States

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT RANGE | DESCRIPTION |
| :---: | :---: | :---: | :---: |
| 3Ah | 803Ah | [0] | PO1 (MAX6870 only). $0=$ active-low, $1=$ active-high. |
|  |  | [1] | PO2 (MAX6870 only). $0=$ active-low, $1=$ active-high. |
|  |  | [2] | PO3 (MAX6870)/PO1 (MAX6871). 0 = active-low, 1 = active-high. |
|  |  | [3] | PO4 (MAX6870)/PO2 (MAX6871). 0 = active-low, 1 = active-high. |
|  |  | [4] | PO5 (MAX6870)/PO3 (MAX6871). 0 = active-low, $1=$ active-high. |
|  |  | [5] | PO6 (MAX6870)/PO4 (MAX6871). $0=$ active-low, $1=$ active-high. |
|  |  | [6] | PO7 (MAX6870)/PO5 (MAX6871). $0=$ active-low, $1=$ active-high. |
|  |  | [7] | PO8 (MAX6870 only). $0=$ active-low, 1 = active-high. |

Table 23. Programmable Output Stage Options (MAX6870)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | $\begin{gathered} \text { BIT } \\ \text { RANGE } \end{gathered}$ | AFFECTED OUTPUT | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: |
| 11h | 8011h | [6:4] | PO1 | $000=$ open-drain, $001=$ weak pullup to $\mathrm{IN} 3,010=$ weak pullup to IN 4 , 011 = weak pullup to IN5, 100 = weak pullup to $\operatorname{IN6}, 101$ = weak pullup to ABP, 110 = charge-pump output, 111 = not used. |
| 15h | 8015h | [6:4] | PO2 |  |
| 1Ch | 801Ch | [7:5] | PO3 |  |
| 23h | 8023h | [7:5] | PO4 |  |
| 2Ah | 802Ah | [7:4] | PO5 | 0000 = open-drain, 0001 = weak pullup to $\operatorname{IN} 3,0010=$ weak pullup to $\operatorname{IN} 4$, 0011 = weak pullup to $\operatorname{IN} 5,0100=$ weak pullup to $\operatorname{IN} 6,0101=$ weak pullup to ABP, 0110 = push-pull to $\operatorname{IN} 3,0111=$ push-pull to $\operatorname{IN} 4,1000=$ push-pull to IN5, 1001 = push-pull to IN6, 1010 through 1111 = not used. |
| 31h | 8031h | [7:4] | PO6 |  |
| 35h | 8035h | [7:4] | PO7 |  |
| 39h | 8039h | [7:4] | PO8 |  |

Table 24. Programmable Output Stage Options (MAX6871)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | $\begin{aligned} & \text { BIT } \\ & \text { RANGE } \end{aligned}$ | AFFECTED OUTPUT | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: |
| 1Ch | 801Ch | [7:5] | PO1 | $000=$ open-drain, $001=$ weak pullup to $\mathrm{IN} 3,010=$ weak pullup to IN 4 , 011-100 = not used, $101=$ weak pullup to ABP, $110=$ charge-pump output, 111 = not used. |
| 23h | 8023h | [7:5] | PO2 |  |
| 2 Ah | 802Ah | [7:4] | PO3 | $0000=$ open-drain, $0001=$ weak pullup to $\mathrm{IN} 3,0010=$ weak pullup to IN 4 , $0011-0100=$ not used, $0101=$ weak pullup to ABP, $0110=$ push-pull to $\operatorname{IN} 3$, 0111 = push-pull to IN4, 1000-1111 = not used. |
| 31h | 8031h | [7:4] | PO4 |  |
| 35h | 8035h | [7:4] | PO5 |  |

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

Table 25. PO_ Timeout Periods

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT RANGE | AFFECTED OUTPUTS |  | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MAX6870 | MAX6871 |  |
| 11h | 8011h | [3:1] | PO1 | - | $\begin{aligned} 000 & =25 \mu \mathrm{~s} \\ 001 & =1.5625 \mathrm{~ms} \\ 010 & =6.25 \mathrm{~ms} \\ 011 & =25 \mathrm{~ms} \\ 100 & =50 \mathrm{~ms} \\ 101 & =200 \mathrm{~ms} \\ 110 & =400 \mathrm{~ms} \\ 111 & =1600 \mathrm{~ms} \end{aligned}$ |
| 15h | 8015h | [3:1] | PO2 | - |  |
| 1Ch | 801Ch | [4:2] | PO3 | PO1 |  |
| 23h | 8023h | [4:2] | PO4 | PO2 |  |
| 2 A | 802Ah | [3:1] | PO5 | PO3 |  |
| 31h | 8031h | [3:1] | PO6 | PO4 |  |
| 35h | 8035h | [3:1] | P07 | PO5 |  |
| 39h | 8039h | [3:1] | PO8 | - |  |

## Charge-Pump Output Configuration

Configure the programmable outputs of the MAX6870/ MAX6871 as charge-pump outputs to drive n-channel FETs for power-supply sequencing applications. Only PO1-PO4 (MAX6870) or PO1 and PO2 (MAX6871) can be configured as charge-pump output stages. The chargepump output high voltage is typically VABP +5.5 V when unloaded.

## Push-Pull Output Configuration

 The MAX6870/MAX6871's programmable outputs sink 4 mA and source 10 mA when configured as push-pull outputs. Only PO5-PO8 (MAX6870), or PO3/PO4/PO5 (MAX6871) can be configured as push-pull output stages. The push-pull output stages refer to any of IN3-IN6 (MAX6870)/IN3/IN4 (MAX6871) as configured in Tables 23 and 24. Use the push-pull output configuration to drive loads with fast rise/fall times, or those with low impedance.
## Weak Pullup Output Configuration

The MAX6870/MAX6871's programmable outputs sink 4 mA when configured as weak pullups. The weak pullup of $10 \mathrm{k} \Omega$ refers to any of IN3-IN6 (MAX6870)/IN3/IN4 (MAX6871) or ABP as configured in Tables 23 and 24. All programmable outputs of the MAX6870/MAX6871 may be configured as weak pullups.

## Open-Drain Output Configuration

Connect an external pullup resistor from the programmable output to an external voltage when configured as an open-drain output. PO1-PO4 (PO1 and PO2 for the MAX6871) may be pulled up to +13.2 V . PO5-PO8 (PO3-PO5 for the MAX6871) may be pulled up to a voltage less than or equal to ABP. Choose the pullup resistor depending on the number of devices connected to the open-drain output and the allowable current consumption. The open-drain output configuration
allows wire-ORed connections, and provides flexibility in setting the pullup current.

## Configuring the MAX6870/MAX6871

The MAX6870/MAX6871 factory-default configuration sets all registers to 00h except 3Ah, which is set to FFh. Each device requires configuration before full power is applied to the system. To configure the MAX6870/ MAX6871, first apply an input voltage to IN1 or one of IN3-IN6 (MAX6870)/IN3/IN4 (MAX6871) (see the Powering the MAX6870/MAX6871 section). VIN1 > +4V or one of $\mathrm{V}_{\mathrm{IN} 3}-\mathrm{V}_{\text {IN6 }}>+2.7 \mathrm{~V}$, to ensure device operation. Next, transmit data through the serial interface. Use the block write protocol to quickly configure the device. Write to the configuration registers first to ensure the device is configured properly. After completing the setup procedure, use the read word protocol to verify the data from the configuration registers. Lastly, use the write word protocol to write this data to the EEPROM registers. After completing EEPROM register configuration, apply full power to the system to begin normal operation. The nonvolatile EEPROM stores the latest configuration upon removal of power. Write O's to all EEPROM registers to clear the memory.

## Software Reboot

A software reboot allows the user to restore the EEPROM configuration to the volatile registers without cycling the power supplies. Use the send byte command with data byte 88h to initiate a software reboot. The 3.5 ms (max) power-up delay also applies after a software reboot.

## SMBus/l²C-Compatible Serial Interface

The MAX6870/MAX6871 feature an $1^{2} \mathrm{C} / \mathrm{SMBus-compati-}$ ble serial interface consisting of a serial data line (SDA) and a serial clock line (SCL). SDA and SCL allow bidirectional communication between the MAX6870/MAX6871

## EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC

and the master device at clock rates up to 400 kHz . Figure 2 shows the interface timing diagram. The MAX6870/MAX6871 are transmit/receive slave-only devices, relying upon a master device to generate a clock signal. The master device (typically a microcontroller) initiates data transfer on the bus and generates SCL to permit that transfer.
A master device communicates to the MAX6870/ MAX6871 by transmitting the proper address followed by command and/or data words. Each transmit sequence is framed by a START (S) or REPEATED START (SR) condition and a STOP (P) condition. Each word transmitted over the bus is 8 bits long and is always followed by an acknowledge pulse.
SCL is a logic input, while SDA is a logic input/opendrain output. SCL and SDA both require external pullup
resistors to generate the logic-high voltage. Use $4.7 \mathrm{k} \Omega$ for most applications.

## Bit Transfer

Each clock pulse transfers one data bit. The data on SDA must remain stable while SCL is high (Figure 3), otherwise the MAX6870/MAX6871 register a START or STOP condition (Figure 4) from the master. SDA and SCL idle high when the bus is not busy.

## Start and Stop Conditions

Both SCL and SDA idle high when the bus is not busy. A master device signals the beginning of a transmission with a START (S) condition (Figure 4) by transitioning SDA from high to low while SCL is high. The master device issues a STOP $(P)$ condition (Figure 4) by transitioning SDA from low to high while SCL is high. A STOP


Figure 2. Serial-Interface Timing Details


Figure 3. Bit Transfer


Figure 4. Start and Stop Conditions

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

condition frees the bus for another transmission. The bus remains active if a REPEATED START condition is generated, such as in the block read protocol (see Figure 7).

## Early STOP Conditions

The MAX6870/MAX6871 recognize a STOP condition at any point during transmission except if a STOP condition occurs in the same high pulse as a START condition. This condition is not a legal $I^{2} \mathrm{C}$ format. At least one clock pulse must separate any START and STOP condition.

## Repeated START Conditions

A REPEATED START (SR) condition may indicate a change of data direction on the bus. Such a change occurs when a command word is required to initiate a read operation (see Figure 7). SR may also be used when the bus master is writing to several $\mathrm{I}^{2} \mathrm{C}$ devices and does not want to relinquish control of the bus. The MAX6870/MAX6871 serial interface supports continuous write operations with or without an SR condition separating them. Continuous read operations require SR conditions because of the change in direction of data flow.

## Acknowledge

The acknowledge bit (ACK) is the 9th bit attached to any 8 -bit data word. The receiving device always generates
an ACK. The MAX6870/MAX6871 generate an ACK when receiving an address or data by pulling SDA low during the 9th clock period (Figure 5). When transmitting data, such as when the master device reads data back from the MAX6870/MAX6871, the MAX6870/MAX6871 wait for the master device to generate an ACK. Monitoring ACK allows for detection of unsuccessful data transfers. An unsuccessful data transfer occurs if the receiving device is busy or if a system fault has occurred. In the event of an unsuccessful data transfer, the bus master should reattempt communication at a later time. The MAX6870/MAX6871 generate a NACK after the slave address during a software reboot, while writing to the EEPROM, or when receiving an illegal memory address.

Slave Address
The MAX6870/MAX6871 slave address conforms to the following table:

| SA7 <br> (MSB) | SA6 | SA5 | SA4 | SA3 | SA2 | SA1 | SA0 <br> (LSB) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | 0 | 1 | 0 | A 1 | A 0 | X | $\mathrm{R} \overline{\mathrm{W}}$ |

$X=$ Don't care.


Figure 5. Acknowledge

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 

SA7 through SA4 represent the standard interface address (1010) for devices with EEPROM. SA3 and SA2 correspond to the A1 and A0 address inputs of the MAX6870/MAX6871 (hard-wired as logic-low or logichigh). SA0 is a read/write flag bit ( $0=$ write, $1=$ read $)$.
The A0 and A1 address inputs allow up to four MAX6870/MAX6871 devices to connect to one bus. Connect A0 and A1 to GND or to the serial interface power supply (see Figure 6).

## Send Byte

The send byte protocol allows the master device to send one byte of data to the slave device (see Figure 7). The send byte presets a register pointer address for a subsequent read or write. The slave sends a NACK instead of an ACK if the master tries to send an address that is not allowed. If the master sends $80 \mathrm{~h}, 81 \mathrm{~h}$, or 82 h , the data is ACK. This could be start of the write byte/word protocol, and the slave expects at least one further data byte. If the master sends a stop condition, the internal address pointer does not change. If the master sends 84 h , this signifies that the block read protocol is expected, and a repeated start condition should follow. The device reboots if the master sends 88 h . The send byte procedure follows:

1) The master sends a start condition.
2) The master sends the 7-bit slave address and a write bit (low).
3) The addressed slave asserts an ACK on SDA.
4) The master sends an 8-bit data byte.
5) The addressed slave asserts an ACK on SDA.
6) The master sends a stop condition.

Write Byte/Word
The write byte/word protocol allows the master device to write a single byte in the register bank, preset an EEPROM (configuration or user) address for a subsequent read, or to write a single byte to the configuration or user EEPROM (see Figure 7). The write byte/word procedure follows:

1) The master sends a start condition.
2) The master sends the 7-bit slave address and a write bit (low).
3) The addressed slave asserts an ACK on SDA.
4) The master sends an 8-bit command code.
5) The addressed slave asserts an ACK on SDA.
6) The master sends an 8-bit data byte.
7) The addressed slave asserts an ACK on SDA.
8) The master sends a stop condition or sends another 8-bit data byte.
9) The addressed slave asserts an ACK on SDA.
10) The master sends a stop condition.

To write a single byte to the register bank, only the 8-bit command code and a single 8 -bit data byte are sent. The command code must be in the range of 00h to 45h. The data byte is written to the register bank if the command code is valid. The slave generates a NACK at step 5 if the command code is invalid.
To preset an EEPROM (configuration or user) address for a subsequent read, the 8-bit command code and a single 8 -bit data byte are sent. The command code must be 80h if the write is to be directed into the configuration EEPROM, or 81 h or 82 h , if the write is to be


Figure 6. Slave Address

## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC



Figure 7. SMBus/I²C Protocols

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

directed into the user EEPROM. If the command code is 80 h , the data byte must be in the range of 00 h to 45 h . If the command code is 81 h or 82 h , the data byte can be OOh to FFh. A NACK is generated in step 7 if none of the above conditions are true.
To write a single byte of data to the user or configuration EEPROM, the 8-bit command code and a single 8-bit data byte are sent. The following 8-bit data byte is written to the addressed EEPROM location.

## Block Write

The block write protocol allows the master device to write a block of data ( 1 to 16 bytes) to the EEPROM or to the register bank (see Figure 7). The destination address must already be set by the send byte or write byte protocol and the command code must be 83h. If the number of bytes to be written causes the address pointer to exceed 45 h for the configuration register or configuration EEPROM, the address pointer stays at 45h, overwriting this memory address with the remaining bytes of data. The last data byte sent is stored at register address 45 h . If the number of bytes to be written exceeds the address pointer FFh for the user EEPROM, the address pointer loops back to 00h, and continues writing bytes until all data is written. The block write procedure follows:

1) The master sends a start condition.
2) The master sends the 7-bit slave address and a write bit (low).
3) The addressed slave asserts an ACK on SDA.
4) The master sends the 8-bit command code for block write (83h).
5) The addressed slave asserts an ACK on SDA.
6) The master sends the 8-bit byte count (1 to 16 bytes) N .
7) The addressed slave asserts an ACK on SDA.
8) The master sends 8-bits of data.
9) The addressed slave asserts an ACK on SDA.
10) Repeat steps 8 and 9 one time.
11) The master generates a stop condition.

Receive Byte The receive byte protocol allows the master device to read the register content of the MAX6870/MAX6871 (see Figure 7). The EEPROM or register address must be preset with a send byte or write word protocol first. Once the read is complete, the internal pointer increases by one. Repeating the receive byte protocol reads
the contents of the next address. The receive byte procedure follows:

1) The master sends a start condition.
2) The master sends the 7-bit slave address and a read bit (high).
3) The addressed slave asserts an ACK on SDA.
4) The slave sends 8 data bits.
5) The master asserts a NACK on SDA.
6) The master generates a stop condition.

## Block Read

The block read protocol allows the master device to read a block of 16 bytes from the EEPROM or register bank (see Figure 7). Read fewer than 16 bytes of data by issuing an early STOP condition from the master, or by generating a NACK with the master. The send byte or write byte protocol predetermines the destination address with a command code of 84 h . The block read procedure follows:

1) The master sends a start condition.
2) The master sends the 7-bit slave address and a write bit (low).
3) The addressed slave asserts an ACK on SDA.
4) The master sends 8 bits of the block read command (84h).
5) The slave asserts an ACK on SDA, unless busy.
6) The master generates a repeated start condition.
7) The master sends the 7-bit slave address and a read bit (high).
8) The slave asserts an ACK on SDA.
9) The slave sends the 8-bit byte count (16).
10) The master asserts an ACK on SDA.
11) The slave sends 8 bits of data.
12) The master asserts an ACK on SDA.
13) Repeat steps 8 and 9 fifteen times.
14) The master generates a stop condition.

## Address Pointers

Use the send byte protocol to set the register address pointers before read and write operations. For the configuration registers, valid address pointers range from 00h to 45h. Register addresses outside of this range result in a NACK being issued from the MAX6870/ MAX6871. When using the block write protocol, the

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

address pointer automatically increments after each data byte, except when the address pointer is already at 45 h . If the address pointer is already 45 h , and more data bytes are being sent, these subsequent bytes overwrite address 45 h repeatedly, leaving only the last data byte sent stored at this register address.
For the configuration EEPROM, valid address pointers range from 8000 h to 8045 h . Registers 8046 h to 804 Fh are reserved and should not be overwritten. Register addresses from 8050h to 80FFh return a NACK from the MAX6870/MAX6871. When using the block write protocol, the address pointer automatically increments after each data byte, except when the address pointer is already at 8045 h . If the address pointer is already 8045h, and more data bytes are being sent, these subsequent bytes overwrite address 8045 h repeatedly, leaving only the last data byte sent stored at this register address.
For the user EEPROM, valid address pointers range from 8100 h to 81 FFh and 8200 h to 82 FFh . Block write and block read protocols allow the address pointer to reset (to 8100 h or 8200 h ) when attempting to write or read beyond 81 FFh or 82FFh.

## Configuration EEPROM

The configuration EEPROM addresses range from 8000h to 8045 h . Write data to the configuration EEPROM to automatically set up the MAX6870/MAX6871 upon powerup. Data transfers from the configuration EEPROM to the configuration registers when ABP exceeds UVLO during power-up or after a software reboot. After ABP exceeds UVLO, an internal 1 MHz clock starts after a $5 \mu \mathrm{~s}$ delay, and data transfer begins. Data transfer disables access
to the configuration registers and EEPROM. The data transfer from EEPROM to configuration registers takes 3.5 ms (max). Read configuration EEPROM data at any time after power-up or software reboot. Write commands to the configuration EEPROM are allowed at any time after power-up or software reboot, unless the configuration lock bit is set (see Table 30). The maximum cycle time to write a single byte is 11 ms (max).

## User EEPROM

The 512 byte user EEPROM addresses range from 8100h to 82FFh (see Figure 8). Store software-revision data, board-revision data, and other data in these registers. The maximum cycle time to write a single byte is 11 ms (max).

Configuration Register Bank and EEPROM The configuration registers can be directly modified by the serial interface without modifying the EEPROM after the power-up procedure terminates and the configuration EEPROM data has been loaded into the configuration register bank. Use the write byte or block write protocols to write directly to the configuration registers. Changes to the configuration registers take effect immediately and are lost upon power removal.
At device power-up, the register bank loads configuration data from the EEPROM. Configuration data may be directly altered in the register bank during application development, allowing maximum flexibility. Transfer the new configuration data, byte by byte, to the configuration EEPROM with the write byte protocol. The next device power-up or software reboot automatically loads the new configuration.

Table 26. Register Map

| REGISTER <br> ADDRESS | EEPROM <br> MEMORY <br> ADDRESS | READ/ <br> WRITE |  |
| :---: | :---: | :---: | :--- |
| 00 h | 8000 h | R/W | IN1 primary undervoltage detector threshold (Table 2). |
| 01 h | 8001 h | R/W | IN2 primary undervoltage detector threshold (Table 3). |
| 02 h | 8002 h | R/W | IN3 primary undervoltage detector threshold (Table 4). |
| 03 h | 8003 h | R/W | IN4 primary undervoltage detector threshold (Table 4). |
| 04 h | 8004 h | R/W | IN5 primary undervoltage detector threshold (MAX6870 only) (Table 4). |
| 05 h | 8005 h | R/W | IN6 primary undervoltage detector threshold (MAX6870 only) (Table 4). |
| 06 h | 8006 h | R/W | IN1 secondary undervoltage/overvoltage detector threshold (Table 2). |
| 07 h | 8007 h | R/W | IN2 secondary undervoltage/overvoltage detector threshold (Table 3). |
| 08 h | 8008 h | R/W | IN3 secondary undervoltage/overvoltage detector threshold (Table 4). |
| 09 h | 8009 h | R/W | IN4 secondary undervoltage/overvoltage detector threshold (Table 4). |
| 0Ah | 800 Ah | R/W | IN5 secondary undervoltage/overvoltage detector threshold (MAX6870 only) (Table 4). |

## EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC

Table 26. Register Map (continued)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | READ/ WRITE | DESCRIPTION |
| :---: | :---: | :---: | :---: |
| OBh | 800Bh | R/W | IN6 secondary undervoltage/overvoltage detector threshold (MAX6870 only) (Table 4). |
| OCh | 800Ch | R/W | Secondary undervoltage/overvoltage selection (Tables 2, 4). |
| 0Dh | 800Dh | R/W | Threshold range selection (Tables 2-4). |
| OEh | 800Eh | R/W | PO1 (MAX6870 only) input selection (Table 10). |
| OFh | 800Fh | R/W | PO1 (MAX6870 only) input selection (Table 10). |
| 10h | 8010h | R/W | PO1 (MAX6870 only) input selection (Table 10). |
| 11h | 8011h | R/W | PO1 (MAX6870 only) input selection, PO_ timeout period, and output type selection (Tables 10, 23, and 25). |
| 12h | 8012h | R/W | PO2 (MAX6870 only) input selection (Table 11). |
| 13h | 8013h | R/W | PO2 (MAX6870 only) input selection (Table 11). |
| 14h | 8014h | R/W | PO2 (MAX6870 only) input selection (Table 11). |
| 15h | 8015h | R/W | PO2 (MAX6870 only) input selection, PO_ timeout period, and output type selection (Tables 11, 23, and 25). |
| 16h | 8016h | R/W | PO3 (MAX6870)/PO1 (MAX6871) input selection—Product 1 (Table 12). |
| 17h | 8017h | R/W | PO3 (MAX6870)/PO1 (MAX6871) input selection—Product 1 (Table 12). |
| 18h | 8018h | R/W | PO3 (MAX6870)/PO1 (MAX6871) input selection—Product 1 (Table 12). |
| 19h | 8019h | R/W | PO3 (MAX6870)/PO1 (MAX6871) input selection-Product 2 (Table 13). |
| 1Ah | 801Ah | R/W | PO3 (MAX6870)/PO1 (MAX6871) input selection-Product 2 (Table 13). |
| 1Bh | 801Bh | R/W | PO3 (MAX6870)/PO1 (MAX6871) input selection-Product 2 (Table 13). |
| 1Ch | 801Ch | R/W | PO3 (MAX6870)/PO1 (MAX6871) input selection—Products 1 and 2, PO_ timeout period, and output type selection (Tables 12, 13, 23, 24, and 25). |
| 1Dh | 801Dh | R/W | PO4 (MAX6870)/PO2 (MAX6871) input selection—Product 1 (Table 14). |
| 1 Eh | 801Eh | R/W | PO4 (MAX6870)/PO2 (MAX6871) input selection—Product 1 (Table 14). |
| 1Fh | 801Fh | R/W | PO4 (MAX6870)/PO2 (MAX6871) input selection—Product 1 (Table 14). |
| 20h | 8020h | R/W | PO4 (MAX6870)/PO2 (MAX6871) input selection—Product 2 (Table 15). |
| 21h | 8021h | R/W | PO4 (MAX6870)/PO2 (MAX6871) input selection—Product 2 (Table 15). |
| 22h | 8022h | R/W | PO4 (MAX6870)/PO2 (MAX6871) input selection—Product 2 (Table 15). |
| 23h | 8023h | R/W | PO4 (MAX6870)/PO2 (MAX6871) input selection—Products 1 and 2, PO_ timeout period, and output type selection (Tables 14, 15, 23, 24, and 25). |
| 24h | 8024h | R/W | PO5 (MAX6870)/PO3 (MAX6871) input selection-Product 1 (Table 16). |
| 25h | 8025h | R/W | PO5 (MAX6870)/PO3 (MAX6871) input selection—Product 1 (Table 16). |
| 26h | 8026h | R/W | PO5 (MAX6870)/PO3 (MAX6871) input selection-Product 1 (Table 16). |
| 27h | 8027h | R/W | PO5 (MAX6870)/PO3 (MAX6871) input selection—Product 2 (Table 17). |
| 28h | 8028h | R/W | PO5 (MAX6870)/PO3 (MAX6871) input selection—Product 2 (Table 17). |
| 29h | 8029h | R/W | PO5 (MAX6870)/PO3 (MAX6871) input selection—Product 2 (Table 17). |
| 2Ah | 802Ah | R/W | PO5 (MAX6870)/PO3 (MAX6871) input selection—Products 1 and 2, PO_ timeout period, and output type selection (Tables 16, 23, 24, and 25). |
| 2Bh | 802Bh | R/W | PO6 (MAX6870)/PO4 (MAX6871) input selection-Product 1 (Table 18). |
| 2Ch | 802Ch | R/W | PO6 (MAX6870)/PO4 (MAX6871) input selection—Product 1 (Table 18). |

## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC

Table 26. Register Map (continued)

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | READ/ WRITE | DESCRIPTION |
| :---: | :---: | :---: | :---: |
| 2Dh | 802Dh | R/W | PO6 (MAX6870)/PO4 (MAX6871) input selection—Product 1 (Table 18). |
| 2Eh | 802Eh | R/W | PO6 (MAX6870)/PO4 (MAX6871) input selection—Product 2 (Table 19). |
| 2Fh | 802Fh | R/W | PO6 (MAX6870)/PO4 (MAX6871) input selection—Product 2 (Table 19). |
| 30h | 8030h | R/W | PO6 (MAX6870)/PO4 (MAX6871) input selection—Product 2 (Table 19). |
| 31h | 8031h | R/W | PO6 (MAX6870)/PO4 (MAX6871) input selection—Products 1 and 2, reset timeout period, and output type selection (Tables 18, 23, 24, and 25). |
| 32h | 8032h | R/W | PO7 (MAX6870)/PO5 (MAX6871) input selection (Table 20). |
| 33h | 8033h | R/W | PO7 (MAX6870)/PO5 (MAX6871) input selection (Table 20). |
| 34h | 8034h | R/W | PO7 (MAX6870)/PO5 (MAX6871) input selection (Table 20). |
| 35h | 8035h | R/W | PO7 (MAX6870)/PO5 (MAX6871) input selection, PO_ timeout period, and output type selection (Tables 20, 23, 24, and 25). |
| 36h | 8036h | R/W | PO8 (MAX6870 only) input selection (Table 21). |
| 37h | 8037h | R/W | PO8 (MAX6870 only) input selection (Table 21). |
| 38h | 8038h | R/W | PO8 (MAX6870 only) input selection (Table 21). |
| 39h | 8039h | R/W | PO8 (MAX6870 only) input selection, PO_ timeout period, and output type selection. (Tables 21, 23, 24, and 25). |
| 3Ah | 803Ah | R/W | Programmable output polarity (active-high/active-low) (Table 22). |
| 3Bh | 803Bh | R/W | GPI_ input polarity, PO5, PO6 (Tables 6, 17, and 19). |
| 3Ch | 803Ch | R/W | WDI1 input selection and timeout enable (Table 27). |
| 3Dh | 803Dh | R/W | WDI1 initial and normal timeout duration (Table 28). |
| 3Eh | 803Eh | R/W | WDI2 input selection and timeout enable (Table 27). |
| 3Fh | 803Fh | R/W | WDI2 initial and normal timeout duration (Table 28). |
| 40h | 8040h | R/W | $\overline{\mathrm{MR}}$ input and programmable output behavior (Table 7). |
| 41h | 8041h | R/W | $\overline{\text { MARGIN }}$ and programmable output behavior (Table 8). |
| 42h | 8042h | R/W | Programmable output state with $\overline{\text { MARGIN }}$ assertion (Table 8). |
| 43h | 8043h | R/W | User EEPROM write disable (Table 31). |
| 44h | 8044h | R/W | Internal/external reference selection (Table 9). |
| 45 h | 8045h | R/W | Configuration lock (Table 30). |
| 46h | 8046h | - | Reserved. Should not be overwritten. |
| 47h | 8047h | - | Reserved. Should not be overwritten. |
| 48h | 8048h | - | Reserved. Should not be overwritten. |
| 49h | 8049h | - | Reserved. Should not be overwritten. |
| 4Ah | 804Ah | - | Reserved. Should not be overwritten. |
| 4Bh | 804Bh | - | Reserved. Should not be overwritten. |
| 4Ch | 804Ch | - | Reserved. Should not be overwritten. |
| 4Dh | 804Dh | - | Reserved. Should not be overwritten. |
| 4Eh | 804Eh | - | Reserved. Should not be overwritten. |
| 4Fh | 804Fh | - | Reserved. Should not be overwritten. |

## EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC

Table 26. Register Map (continued)

| REGISTER <br> ADDRESS | EEPROM <br> MEMORY <br> ADDRESS | READ/ <br> WRITE |  |
| :---: | :---: | :---: | :--- |
| 50 h | - | $R$ | ADC data for IN1 (8 MSBs). |
| 51 h | - | $R$ | ADC data for IN1 (2 LSBs). |
| 52 h | - | $R$ | ADC data for IN2 (8 MSBs). |
| 53 h | - | $R$ | ADC data for IN2 (2 LSBs). |
| 54 h | - | $R$ | ADC data for IN3 (8 MSBs). |
| 55 h | - | $R$ | ADC data for IN3 (2 LSBs). |
| 56 h | - | $R$ | ADC data for IN4 (8 MSBs). |
| 57 h | - | $R$ | ADC data for IN4 (2 LSBs). |
| 58 h | - | $R$ | ADC data for IN5 (8 MSBs, MAX6870 only). |
| 59 h | - | $R$ | ADC data for IN5 (2 LSBs, MAX6870 only). |
| 5 Ah | - | $R$ | ADC data for IN6 (8 MSBs, MAX6870 only). |
| $5 B h$ | - | $R$ | ADC data for IN6 (2 LSBs, MAX6870 only). |
| $5 C h$ | - | $R$ | ADC data for AUXIN1 (8 MSBs) (Table 5). |
| $5 D h$ | - | $R$ | ADC data for AUXIN1 (2 LSBs) (Table 5). |
| $5 E h$ | - | $R$ | ADC data for AUXIN2 (8 MSBs) (Table 5). |
| $5 F h$ | - | $R$ | ADC data for AUXIN2 (2 LSBs) (Table 5). |
| $60 h$ | - | $R$ | Fault flags for IN1-IN6 (primary thresholds) (Table 29). |
| 61 h | - | $R$ | Fault flags for IN1-IN6 (secondary thresholds) (Table 29). |
| 62 h | - | $R$ | Fault flags for WDI_, GPI_, and MR (Table 29). |



Figure 8. Memory Map

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

## Configuring the Watchdog Timers <br> (Registers 3Ch-3Fh)

A watchdog timer monitors microprocessor ( $\mu \mathrm{P}$ ) software execution for a stalled condition and resets the $\mu \mathrm{P}$ if it stalls. The output of a watchdog timer (one of the programmable outputs) connects to the reset input or a nonmaskable interrupt of the $\mu \mathrm{P}$.
Registers 3Ch-3Fh configure the watchdog functionality of the MAX6870/MAX6871. Program each watchdog timer to assert one or more programmable outputs (see Tables 10-21). Program each watchdog timer to reset on one of the GPI_ inputs, one of the programmable outputs, or a combination of one GPI_ input and one programmable output.
Each watchdog timer features independent initial and normal watchdog timeout periods. The initial watchdog timeout period applies immediately after power-up, after a reset event takes place, or after enabling the watchdog timer. The initial watchdog timeout period allows the $\mu \mathrm{P}$ to

## Table 27. Watchdog Inputs (Addresses 3Ch (Watchdog 1), 3Eh (Watchdog 2))

| BIT | NAME | DESCRIPTION |
| :---: | :---: | :---: |
| [1:0] | Watchdog <br> Input Selection | $\begin{aligned} & 00=\text { GPI1 input } \\ & 01=\text { GPI2 input } \\ & 10=\text { GPI3 input } \\ & 11=\text { GPI4 input } \end{aligned}$ |
| [4:2] | Watchdog <br> Internal <br> Input <br> Selection | $000=$ PO1 (MAX6870), not used (MAX6871) <br> 001 = PO2 (MAX6870), not used (MAX6871) <br> $010=$ PO3 (MAX6870), PO1 (MAX6871) <br> 011 = PO4 (MAX6870), PO2 (MAX6871) <br> $100=$ PO5 (MAX6870), PO3 (MAX6871) <br> 101 = PO6 (MAX6870), PO4 (MAX6871) <br> $110=$ PO7 (MAX6870), PO5 (MAX6871) <br> 111 = PO8 (MAX6870), not used (MAX6871) |
| [6:5] | Watchdog Dependency on Inputs | $00=11=$ watchdog clear depends on both GPI_ from 3Ch[1:0] and PO_ from 3Ch[4:2]. <br> 01 = watchdog clear depends only on PO_ from 3Ch[4:2]. <br> 10 = watchdog clear depends only on GPI_ from 3Ch[1:0]. |
| [7] | Initial <br> Watchdog Timeout Enable | $0=$ disables initial watchdog timeout period (normal watchdog timeout not affected). <br> 1 = enables initial watchdog timeout period. |

perform its initialization process. If no pulse occurs during the initial watchdog timeout period, the $\mu \mathrm{P}$ is taking too long to initialize, indicating a potential problem.
The normal watchdog timeout period applies in every other cycle after the initial watchdog timeout period occurs. The normal watchdog timeout period monitors a pulsed output of the $\mu \mathrm{P}$ that indicates when normal processor behavior occurs. If no pulse occurs during the normal watchdog timeout period, this indicates that the processor has stopped operating or is stuck in an infinite execution loop.

Disable or enable each initial timeout period through registers 3Ch and 3Eh. Registers 3Dh and 3Fh program the initial and normal watchdog timeout periods, and enable or disable each watchdog timer. See Tables 27 and 28 for a summary of the watchdog behavior.

Fault Detector
Registers 60h-62h store all fault conditions, including undervoltage, overvoltage, GPI_, and watchdog timer faults (see Table 29). Fault registers are read-only and lose contents upon power removal. The first read command from the fault registers after power-up gives invalid data. Any $\overline{\mathrm{MR}}$ assertion writes to the fault register. Reading the fault register clears all fault flags. Both GPI_

Table 28. Watchdog Timeout Period Selection (Addresses 3Dh (Watchdog 1), 3Fh (Watchdog 2))

| BIT | NAME | DESCRIPTION |
| :---: | :---: | :---: |
| [2:0] | Normal Watchdog Timeout Period | $\begin{aligned} & 000=6.25 \mathrm{~ms} \\ & 001=25 \mathrm{~ms} \\ & 010=100 \mathrm{~ms} \\ & 011=400 \mathrm{~ms} \\ & 100=1.6 \mathrm{~s} \\ & 101=6.4 \mathrm{~s} \\ & 110=25.6 \mathrm{~s} \\ & 111=102.4 \mathrm{~s} \end{aligned}$ |
| [5:3] | Initial Watchdog <br> Timeout Period (Immediately following powerup, reset event, or enabling watchdog) | $\begin{aligned} & 000=6.25 \mathrm{~ms} \\ & 001=25 \mathrm{~ms} \\ & 010=100 \mathrm{~ms} \\ & 011=400 \mathrm{~ms} \\ & 100=1.6 \mathrm{~s} \\ & 101=6.4 \mathrm{~s} \\ & 110=25.6 \mathrm{~s} \\ & 111=1.20 .4 \mathrm{~s} \end{aligned}$ |
| [6] | Watchdog Enable | $\begin{aligned} & 0=\text { disables watchdog timer } \\ & 1=\text { enables watchdog timer } \end{aligned}$ |
| [7] | - | Not used |

## EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC

Table 29. Fault Registers (60h-62h)

| REGISTER ADDRESS | BIT RANGE | DESCRIPTION |
| :---: | :---: | :---: |
| 60h | [0] | $1=$ IN1 falls below primary undervoltage threshold. |
|  | [1] | $1=$ IN2 falls below primary undervoltage threshold. |
|  | [2] | $1=$ IN3 falls below primary undervoltage threshold. |
|  | [3] | 1 = IN4 falls below primary undervoltage threshold. |
|  | [4] | 1 = IN5 (MAX6870 only) falls below primary undervoltage threshold. |
|  | [5] | 1 = IN6 (MAX6870 only) falls below primary undervoltage threshold. |
|  | [7:6] | Not used. |
| 61h | [0] | $1=\operatorname{IN} 1$ falls below secondary undervoltage threshold or rises above secondary overvoltage threshold, depending on the settings in register 0Ch (see Tables 2, 3, and 4). |
|  | [1] | $1=\operatorname{IN} 2$ falls below secondary undervoltage threshold or rises above secondary overvoltage threshold, depending on the settings in register OCh (see Tables 2, 3, and 4). |
|  | [2] | $1=$ IN3 falls below secondary undervoltage threshold or rises above secondary overvoltage threshold, depending on the settings in register 0Ch (see Tables 2, 3, and 4). |
|  | [3] | $1=\operatorname{IN} 4$ falls below secondary undervoltage threshold or rises above secondary overvoltage threshold, depending on the settings in register OCh (see Tables 2, 3, and 4). |
|  | [4] | 1 = IN5 (MAX6870 only) falls below secondary undervoltage threshold or rises above secondary overvoltage threshold, depending on the settings in register 0Ch (see Tables 2, 3, and 4). |
|  | [5] | 1 = IN6 (MAX6870 only) falls below secondary undervoltage threshold or rises above secondary overvoltage threshold, depending on the settings in register 0Ch (see Tables 2, 3, and 4). |
|  | [7:6] | Not used. |
| 62h | [0] | 1 = WDI1 asserted. |
|  | [1] | 1 = WDI2 asserted. |
|  | [2] | 1 = GPI1 asserted. |
|  | [3] | 1 = GPI2 asserted. |
|  | [4] | 1 = GPI3 asserted. |
|  | [5] | 1 = GPI4 asserted. |
|  | [6] | 1 = $\overline{\mathrm{MR}}$ asserted. |
|  | [7] | Not used. |

and WDI_ bits assert if any of the GPI_ inputs are configured as watchdog inputs (WDI_) and a watchdog fault occurs.

## Configuration Lock

Lock the configuration register bank and configuration EEPROM contents after initial programming by setting the lock bit high (see Table 30). Locking the configuration prevents write operations to all registers except the configuration lock register. Clear the lock bit to reconfigure the device.

Write Disable A unique write disable feature protects the MAX6870/ MAX6871 from inadvertent user EEPROM writes. As input voltages that power the serial interface, a $\mu \mathrm{P}$, or any other writing devices fall, unintentional data may be written onto the data bus. The user EEPROM write disable function (see Table 31) ensures that unintentional data does not corrupt the MAX6870/MAX6871 EEPROM data.

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

Table 30. Configuration Lock Register

| REGISTER <br> ADDRESS | EEPROM <br> MEMORY <br> ADDRESS | BIT <br> RANGE |  |
| :---: | :---: | :---: | :--- |
|  | 8045 h | $[0]$ | $0=$ configuration unlocked. <br> $1=$ configuration locked. |
|  | $[7: 1]$ | Not used. |  |

Table 31. Write Disable Register

| REGISTER ADDRESS | EEPROM MEMORY ADDRESS | BIT RANGE | DESCRIPTION |
| :---: | :---: | :---: | :---: |
| 43h | 8043h | [0] | $0=$ write not disabled if PO1 asserts (MAX6870). <br> 1 = write disabled if PO1 asserts (MAX6870). Set to 0 (MAX6871). |
|  |  | [1] | $0=$ write not disabled if PO2 asserts (MAX6870). <br> 1 = write disabled if PO2 asserts (MAX6870). Set to 0 (MAX6871). |
|  |  | [2] | $0=$ write not disabled if PO3 (MAX6870)/PO1 (MAX6871) asserts. 1 = write disabled if PO3 (MAX6870)/PO1 (MAX6871) asserts. |
|  |  | [3] | $0=$ write not disabled if PO4 (MAX6870)/PO2 (MAX6871) asserts. <br> 1 = write disabled if PO4 (MAX6870)/PO2 (MAX6871) asserts. |
|  |  | [4] | $0=$ write not disabled if PO5 (MAX6870)/PO3 (MAX6871) asserts. 1 = write disabled if PO5 (MAX6870)/PO3 (MAX6871) asserts. |
|  |  | [5] | $0=$ write not disabled if PO6 (MAX6870)/PO4 (MAX6871) asserts. <br> 1 = write disabled if PO6 (MAX6870)/PO4 (MAX6871) asserts. |
|  |  | [6] | $0=$ write not disabled if PO7 (MAX6870)/PO5 (MAX6871) asserts. 1 = write disabled if PO7 (MAX6870)/PO5 (MAX6871) asserts. |
|  |  | [7] | $0=$ write not disabled if PO8 asserts (MAX6870). <br> 1 = write disabled if PO8 asserts (MAX6870). Set to 0 (MAX6871). |

## Applications Information

## Configuration Download at Power-up

The configuration of the MAX6870/MAX6871 (undervoltage/overvoltage thresholds, PO _ timeout periods, watchdog behavior, programmable output conditions and configurations, etc.) depends on the contents of the EEPROM. The EEPROM is comprised of buffered latches that store the configuration. The local volatile memory latches lose their contents at power-down. Therefore, at power-up, the device configuration must be restored by downloading the contents of the EEPROM (non-volatile memory) to the local latches. This download occurs in a number of steps:

1) Programmable outputs go high impedance with no power applied to the device.
2) When ABP exceeds +1V, all programmable outputs are weakly pulled to GND through a $10 \mu \mathrm{~A}$ current sink.
3) When ABP exceeds UVLO, the configuration EEPROM starts to download its contents to the volatile configuration registers. The programmable outputs assume their programmed conditional output state when download is complete.
4) Any attempt to communicate with the device prior to this download completion results in a NACK being issued from the MAX6870/MAX6871.

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 


#### Abstract

Forcing Programmable Outputs High During Power-Up A weak $10 \mu \mathrm{~A}$ pulldown holds all programmable outputs low during power-up until ABP exceeds the undervoltage lockout (UVLO) threshold. Applications requiring a guaranteed high programmable output for ABP down to GND require external pullup resistors to maintain the logic state until ABP exceeds UVLO. Use $20 \mathrm{k} \Omega$ resistors for most applications.

\section*{Driving High-Side MOSFET}

Switches with the MAX6870/MAX6871


High-side MOSFET switches are commonly used in power-supply sequencing applications. First, configure the programmable output of the MAX6870/MAX6871 as an active-low charge-pump output and set the conditions to assert this output. Connect the programmable output to the gate of an n-channel MOSFET. As the conditions to deassert this output are met, the output deasserts high (VABP +5 V ), turning on the FET , thus allowing the voltage on the drain to pass through to the downstream device (see Figure 9).

## Uses for GeneralPurpose Inputs (GPI1-GPI4)

Watchdog Timer
Program GPI_ as an input to one of the watchdog timers in the MAX6870/MAX6871. The GPI_ input must toggle within the watchdog timeout period, otherwise any programmable output dependent on the watchdog timer asserts.


Figure 9. Driving High-Side n-Channel MOSFET Switches

## Additional Manual Reset Functions

The PO7 (MAX6870)/PO5 (MAX6871) programmable outputs allow a single set (Product 1 only) of conditions to assert the output. Program the set of conditions to depend on one of the GPI_ inputs. Any output that depends on GPI_ asserts when GPI_ is held in its active state, effectively acting as a manual reset input.

Other Fault Signals from $\boldsymbol{\mu} \mathbf{C}$ Connect a general purpose output from a $\mu \mathrm{C}$ to one of the GPI_ inputs to allow interrupts to assert any output of the MAX6870/MAX6871. Configure one of the programmable outputs to assert on whichever GPI_ input connects to the general purpose output of the $\mu \mathrm{C}$.

## Uses for AUXIN1 and AUXIN2

## Analog Output of Current-Sense Amplifier

Figure 10 shows the MAX6870/MAX6871 in a currentsensing application with the MAX4374. The MAX4374 generates an analog output voltage (OUT) proportional to the voltage difference between RS+ and RS- and a latched comparator output (COUT) indicating an overcurrent condition. Connect OUT to AUXIN1 to provide continuous monitoring of the load current on the 12 V supply. The internal ADC of the MAX6870/MAX6871 digitizes VOUT and stores the results in read-only registers 5Ch through 5Fh. COUT latches high for VCIN > 600 mV , and clears with the RESET input of the MAX4374. Configure GPI1 as an active-high input and configure PO7 (MAX6870)/PO5 (MAX6871) to depend on GPI1. PO7/PO5 asserts to its active state when an overcurrent condition exists.


Figure 10. Monitoring Current-Sense Amplifier Outputs

# EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC 

Temperature Sensor Outputs
Figure 11 shows the MAX6870/MAX6871 in a tempera-ture-sensing application with the DS600. The DS600 generates an analog output voltage proportional to the sensed temperature through VOUT and logic outputs on TO and TO (only TO is shown). The internal ADC of the MAX6870/MAX6871 digitizes the analog output voltage of the DS600 and stores the results in read-only registers 5 Ch through 5 Fh . $\mathrm{V}_{\mathrm{TH}}$ sets the threshold voltage that VOUT must exceed for TO to generate a logic-high signal. $V_{\text {TH }}$ must be less than 1.25 V , otherwise the overcurrent condition will occur after the internal ADC attains its full-scale input voltage. Configure GPI1 as an active-high input and configure PO7 (MAX6870)/PO5 (MAX6871) to depend on GPI1. When Vout increases above $\mathrm{V}_{\mathrm{TH}}$, TO asserts high, causing PO7/PO5 to assert to its active state.


Figure 11. Temperature Sensor Outputs

## Monitoring Other Voltages

Use AUXIN_ to monitor any voltage up to 1.25 V . The internal ADC of the MAX6870/MAX6871 digitizes the voltage and stores the results in read-only registers 5Ch through 5Fh. The internal ADC cycles through the voltage monitor inputs and the auxiliary inputs every 200 ms .

Layout and Bypassing
For better noise immunity, bypass each of the voltage detector inputs to GND with $0.1 \mu \mathrm{~F}$ capacitors installed as close to the device as possible. Bypass ABP and DBP to GND with $1 \mu \mathrm{~F}$ capacitors installed as close to the device as possible. ABP and DBP are internally generated voltages and should not be used to supply power to external circuitry.

## Configuration Latency Period

A delay of less than $5 \mu$ s occurs between writing to the configuration registers and the time when these changes actually take place, except when changing one of the voltage-detector thresholds. Changing a voltage-detector threshold typically takes $150 \mu \mathrm{~s}$. When changing EEPROM contents, a software reboot or cycling of power is required for these changes to transfer to volatile memory.

Chip Information
PROCESS: BiCMOS

# EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC 



Selector Guide

| PART | VOLTAGE- <br> DETECTOR INPUTS | INTERNAL ADC | GENERAL-PURPOSE <br> INPUTS | PROGRAMMABLE <br> OUTPUTS | AUXILIARY <br> INPUTS |
| :---: | :---: | :---: | :---: | :---: | :---: |
| MAX6870ETJ | 6 | $\checkmark$ | 4 | 8 | $\sqrt{ }$ |
| MAX6871ETJ | 4 | $\checkmark$ | 4 | 5 | $V$ |

## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC




## EEPROM-Programmable Hex/Quad <br> Power-Supply Sequencers/Supervisors with ADC

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information, go to www.maxim-ic.com/packages.)


## EEPROM-Programmable Hex/Quad Power-Supply Sequencers/Supervisors with ADC

Package Information (continued)
(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information, go to www.maxim-ic.com/packages.)

| COMMON DIMENSIONS |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PKG | 32L 7x7 |  |  | 44L 7x7 |  |  | 48L 7x7 |  |  | CUSTOM PKG. (T4877-1) 48L 7x7 |  |  | 56L 7x7 |  |  |
| SYMBOL | MIN. | NOM. | Max. | MN. | NOM. | max. | MN. | NOM. | max. | MIN. | NOM. | MAX. | MIN. | NOM. | max. |
| A | 0.70 | 0.75 | 0.80 | 0.70 | 0.75 | 0.80 | 0.70 | 0.75 | 0.80 | 0.70 | 0.75 | 0.80 | 0.70 | 0.75 | 0.80 |
| AI | 0 | 0.02 | 0.05 | 0 | 0.02 | 0.05 | 0 | 0.02 | 0.05 | 0 | 0.02 | 0.05 | 0 | - | 0.05 |
| A2 | 0.20 REF. |  |  | 0.20 REF. |  |  | 0.20 REF. |  |  | 0.20 REF. |  |  | 0.20 REF. |  |  |
| $b$ | 0.25 | 0.30 | 0.35 | 0.20 | 0.25 | 0.30 | 0.20 | 0.25 | 0.30 | 0.20 | 0.25 | 0.30 | 0.15 | 0.20 | 0.25 |
| D | 6.90 | 7.00 | 7.10 | 6.90 | 7.00 | 7.10 | 6.90 | 7.00 | 7.10 | 6.90 | 7.00 | 7.10 | 6.90 | 7.00 | 7.10 |
| E | 6.90 | 7.00 | 7.10 | 6.90 | 7.00 | 7.10 | 6.90 | 7.00 | 7.10 | 6.90 | 7.00 | 7.10 | 6.90 | 7.00 | 7.10 |
| c | 0.65 BSC. |  |  | 0.50 BSC. |  |  | 0.50 日SC. |  |  | 0.50 BSC. |  |  | 0.40 BSC. |  |  |
| k | 0.25 | - | - | 0.25 | - | - | 0.25 | - | - | 0.25 | - | - | 0.25 | 0.35 | 0.45 |
| L | 0.45 | 0.55 | 0.65 | 0.45 | 0.55 | 0.65 | 0.30 | 0.40 | 0.50 | 0.45 | 0.55 | 0.65 | 0.40 | 0.50 | 0.60 |
| L1 | - | - | - | - | - | - | - | - | - | - | - | - | 0.30 | 0.40 | 0.50 |
| N | 32 |  |  | 44 |  |  | 48 |  |  | 44 |  |  | 58 |  |  |
| ND | 8 |  |  | 11 |  |  | 12 |  |  | 10 |  |  | 14 |  |  |
| NE | 8 |  |  | 11 |  |  | 12 |  |  | 12 |  |  | 14 |  |  |


| EXPOSED PAD VARLATIONS |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PKG. CODES | $\begin{aligned} & \text { DPPOPULATED } \\ & \text { LEADS } \end{aligned}$ | D2 |  |  | E2 |  |  | $\begin{aligned} & \text { JEDEC } \\ & \text { MO220 } \\ & \text { REV. } \end{aligned}$ | $\begin{array}{\|c} \text { DOWN } \\ \text { BONDS } \\ \text { ALOWED } \end{array}$ |
|  |  | MN. | NOM. | max. | MN. | NOM. | MAX. |  |  |
| T3277-1 | - | 4.55 | 4.70 | 4.85 | 4.55 | 4.70 | 4.85 | - | NO |
| T3277-2 | - | 4.55 | 4.70 | 4.85 | 4.55 | 4.70 | 4.85 | - | YES |
| T4477-1 | - | 4.55 | 4.70 | 4.85 | 4.55 | 4.70 | 4.85 | WKKD-1 | NO |
| T4477-2 | - | 4.55 | 4.70 | 4.85 | 4.55 | 4.70 | 4.85 | WKKD-1 | YES |
| T4477-3 | - | 4.55 | 4.70 | 4.85 | 4.55 | 4.70 | 4.85 | WKKD-1 | YES |
| T4877-1* | 13,24,37,48 | 4.20 | 4.30 | 4.40 | 4.20 | 4.30 | 4.40 | - | NO |
| T4877-2 | - | 5.45 | 5.60 | 5.63 | 5.45 | 5.60 | 5.63 | - | NO |
| T4877-3 | - | 4.95 | 5.10 | 5.25 | 4.95 | 5.10 | 5.25 | - | YES |
| T4877-4 | - | 5.45 | 5.60 | 5.63 | 5.45 | 5.60 | 5.63 | - | YES |
| T4877-5 | - | 2.40 | 2.50 | 2.60 | 2.40 | 2.50 | 2.60 | - | NO |
| T4877-6 | - | 5.45 | 5.60 | 5.63 | 5.45 | 5.60 | 5.63 | - | NO |
| T5677-1 | - | 5.20 | 5.30 | 5.40 | 5.20 | 5.30 | 5.40 | - | YES |

** NOTE: T4877-1 IS A CUSTOM 4BL PKG. WITH 4 LEADS DEPOPULATED. TOTAL NUMBER OF LEADS ARE 44.

NOTES:

1. DIMENSIONING \& TOLERANCING CONFORM TO ASME Y14.SM-1994.
2. ALL dimensions are in millimeters. angles are in degrees.
3. $N$ is the total number of terminals.
4. THE TERMINAL \#1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JESD 95-1

SPP-012. DETALLS OF TERMINAL $\$ 1$ IDENTIFER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN
the zone indicated. the terminal \#1 ldentifier may be either a mold or marked feature.
5. DIMENSION D APPLLES TO METALLIZED TERMINAL AND IS MEASURED BETWEEN
0.25 mm AND 0.30 mm FROM TERMINAL TIP.
6. nd and ne refer to the number of terminals on each d and e side respectively.
7. DEPOPULATION IS POSSIBLE IN A STMMETRICAL FASHION.
8. coplanarity applies to the exposed heat sink slug as wel as the terminals.
9. DRAWING CONFORMS TO JEDEC MO220 EXCEPT THE EXPOSED PAD DIMENSIONS OF T3277-1; T4877-1/-2/-3/-4/-5/-6 \& T5677-1.
10. WARPAGE SHALL NOT EXCEED 0.10 mm .


[^1] implied. Maxim reserves the right to change the circuitry and specifications without notice at any time.


[^0]:    SMBus is a trademark of Intel Corp.

[^1]:    Maxim cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim product. No circuit patent licenses are

